

Dual-Output, Low Dropout Voltage Regulators with Power-Up Sequencing for Split-Voltage DSP Systems

FEATURES

- Dual Output Voltages for Split-Supply Applications
- Selectable Power-Up Sequencing for DSP Applications (See Part Number **TPS708xx** for Independent Enable Outputs)
- Output Current Range of 250mA on Regulator 1 and 125mA on Regulator 2
- Fast Transient Response
- Voltage Options: 3.3V/2.5V, 3.3V/1.8V, 3.3V/1.5V, 3.3V/1.2V, and Dual Adjustable Outputs
- Open Drain Power-On Reset with 120ms Delay
- Open Drain Power Good for Regulator 1
- Ultralow 190 μ A (typ) Quiescent Current
- 1 μ A Input Current During Standby
- Low Noise: 65 μ V_{RMS} Without Bypass Capacitor
- Quick Output Capacitor Discharge Feature
- Two Manual Reset Inputs
- 2% Accuracy Over Load and Temperature
- Undervoltage Lockout (UVLO) Feature
- 20-Pin PowerPAD™ TSSOP Package
- Thermal Shutdown Protection

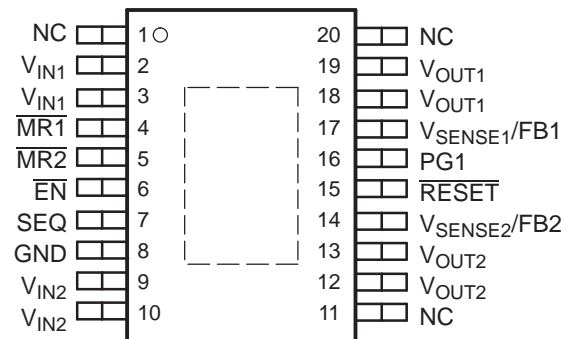
DESCRIPTION

TPS707xx family devices are designed to provide a complete power management solution for the TMS320™ DSP family, processor power, ASIC, FPGA, and digital applications where dual output voltage regulators are required. Easy programmability of the sequencing function makes the TPS707xx family ideal for any TMS320 DSP applications with power sequencing requirements. Differentiated features, such as accuracy, fast transient response, SVS supervisory circuit, manual reset inputs, and an enable function, provide a complete system solution.

The TPS707xx family of voltage regulators offer very low dropout voltage and dual outputs with power-up sequence control, which is designed primarily for DSP applications. These devices have extremely low noise output performance without using any added filter bypass capacitors and are designed to have a fast transient response and be stable with 10 μ F low ESR capacitors.

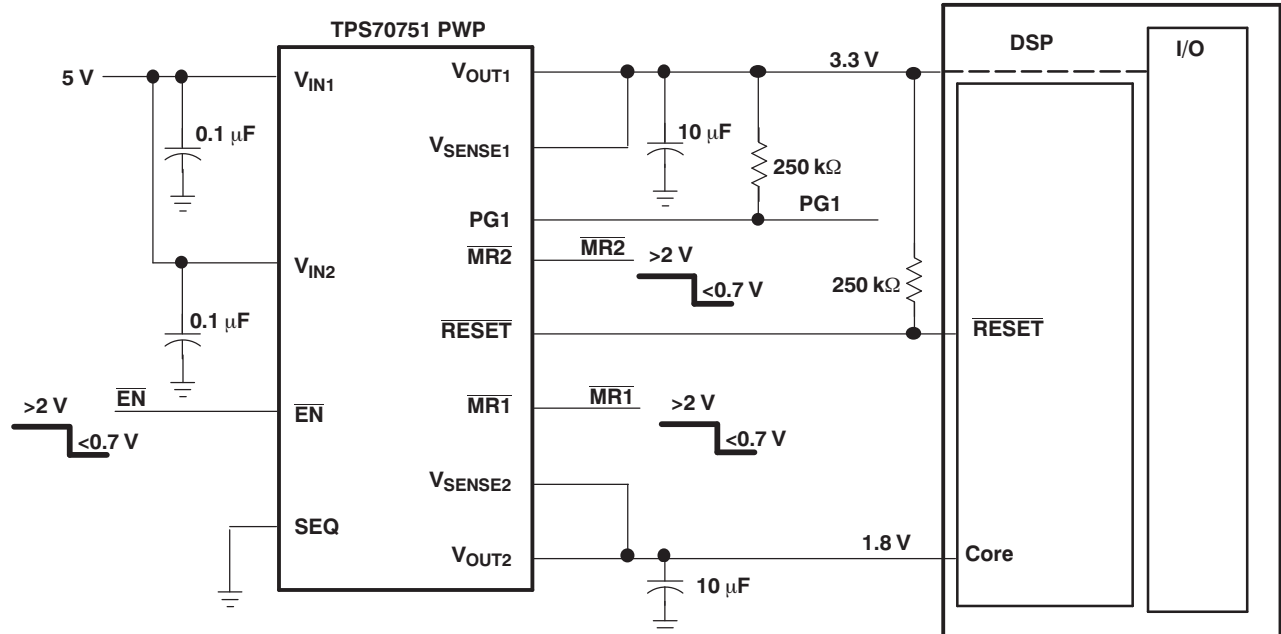
These devices have fixed 3.3V/2.5V, 3.3V/1.8V, 3.3V/1.5V, 3.3V/1.2V, and adjustable/adjustable voltage options. Regulator 1 can support up to 250mA, and regulator 2 can support up to 125mA. Separate voltage inputs allow the designer to configure the source power.

**PWP PACKAGE
(TOP VIEW)**



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Because the PMOS device behaves as a low-value resistor, the dropout voltage is very low (typically 83mV on regulator 1) and is directly proportional to the output current. Additionally, because the PMOS pass element is a voltage-driven device, the quiescent current is very low and independent of output loading (maximum of 230µA over the full range of output current). This LDO family also features a sleep mode; applying a high signal to \overline{EN} (enable) shuts down both regulators, reducing the input current to 1µA at $T_J = +25^\circ\text{C}$.

The device is enabled when the \overline{EN} pin is connected to a low-level input voltage. The output voltages of the two regulators are sensed at the V_{SENSE1} and V_{SENSE2} pins, respectively.

The input signal at the SEQ pin controls the power-up sequence of the two regulators. When the device is enabled and the SEQ terminal is pulled high or left open, V_{OUT2} turns on first and V_{OUT1} remains off until V_{OUT2} reaches approximately 83% of its regulated output voltage. At that time V_{OUT1} is turned on. If V_{OUT2} is pulled below 83% (for example, an overload condition), V_{OUT1} is turned off. Pulling the SEQ terminal low reverses the power-up order and V_{OUT1} is turned on first. The SEQ pin is connected to an internal pull-up current source.

For each regulator, there is an internal discharge transistor to discharge the output capacitor when the regulator is turned off (disabled).

The PG1 pin reports the voltage conditions at V_{OUT1} , which can be used to implement an SVS for the circuitry supplied by regulator 1.

The TPS707xx features a \overline{RESETE} (SVS, POR, or Power-On Reset). \overline{RESETE} output initiates a reset in DSP systems and related digital applications in the event of an undervoltage condition. \overline{RESETE} indicates the status of V_{OUT2} and both manual reset pins ($\overline{MR1}$ and $\overline{MR2}$). When V_{OUT2} reaches 95% of its regulated voltage and $\overline{MR1}$ and $\overline{MR2}$ are in the logic high state, \overline{RESETE} goes to a high impedance state after a 120ms delay. \overline{RESETE} goes to the logic low state when the V_{OUT2} regulated output voltage is pulled below 95% (for example, an overload condition) of its regulated voltage. To monitor V_{OUT1} , the PG1 output pin can be connected to $\overline{MR1}$ or $\overline{MR2}$.

The device has an undervoltage lockout (UVLO) circuit that prevents the internal regulators from turning on until V_{IN1} reaches 2.5V.



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION⁽¹⁾

| PRODUCT | VOLTAGE (V) ⁽²⁾ | | PACKAGE-LEAD (DESIGNATOR) | SPECIFIED TEMPERATURE RANGE (T _J) | ORDERING NUMBER | TRANSPORT MEDIA, QUANTITY |
|----------|----------------------------|-------------------|---------------------------|---|-----------------|---------------------------|
| | V _{OUT1} | V _{OUT2} | | | | |
| TPS70702 | Adjustable | Adjustable | HTSSOP-24 (PWP) | -40°C to +125°C | TPS70702PWP | Tube, 70 |
| | | | | | TPS70702PWPR | Tape and Reel, 2000 |
| TPS70745 | 3.3 V | 1.2 V | HTSSOP-24 (PWP) | -40°C to +125°C | TPS70745PWP | Tube, 70 |
| | | | | | TPS70745PWPR | Tape and Reel, 2000 |
| TPS70748 | 3.3 V | 1.5 V | HTSSOP-24 (PWP) | -40°C to +125°C | TPS70748PWP | Tube, 70 |
| | | | | | TPS70748PWPR | Tape and Reel, 2000 |
| TPS70751 | 3.3 V | 1.8 V | HTSSOP-24 (PWP) | -40°C to +125°C | TPS70751PWP | Tube, 70 |
| | | | | | TPS70751PWPR | Tape and Reel, 2000 |
| TPS70758 | 3.3 V | 2.5 V | HTSSOP-24 (PWP) | -40°C to +125°C | TPS70758PWP | Tube, 70 |
| | | | | | TPS70758PWPR | Tape and Reel, 2000 |

(1) For the most current package and ordering information see the Package Option Addendum located at the end of this document, or see the TI web site at www.ti.com.

(2) For fixed 1.20V operation, tie FB to OUT.

ABSOLUTE MAXIMUM RATINGS

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | TPS707xx | UNIT |
|---|-------------------------------|------|
| Input voltage range: V _{IN1} , V _{IN2} ⁽²⁾ | -0.3 to +7 | V |
| Voltage range at EN | -0.3 to +7 | V |
| Output voltage range (V _{OUT1} , V _{SENSE1}) | 5.5 | V |
| Output voltage range (V _{OUT2} , V _{SENSE2}) | 5.5 | V |
| Maximum RESET, PG1 voltage | 7 | V |
| Maximum MR1, MR2, and SEQ voltage | V _{IN1} | V |
| Peak output current | Internally limited | |
| Continuous total power dissipation | See Dissipation Ratings Table | |
| Junction temperature range, T _J | -40 to +150 | °C |
| Storage temperature range, T _{stg} | -65 to +150 | °C |
| ESD rating, HBM | 2 | kV |

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are tied to network ground.

DISSIPATION RATINGS

| PACKAGE | AIR FLOW (CFM) | T _A ≤ +25°C | DERATING FACTOR | T _A = +70°C | T _A = +85°C |
|--------------------|----------------|------------------------|-----------------|------------------------|------------------------|
| PWP ⁽¹⁾ | 0 | 3.067W | 30.67mW/°C | 1.687W | 1.227W |
| | 250 | 4.115W | 41.15mW/°C | 2.265W | 1.646W |

(1) This parameter is measured with the recommended copper heat sink pattern on a 4-layer PCB, 1 oz. copper on a 4-in by 4-in ground layer. For more information, refer to TI technical brief [SLMA002](#).

RECOMMENDED OPERATING CONDITIONS

Over operating temperature range (unless otherwise noted).

| | MIN | MAX | UNIT |
|--|------|------|------|
| Input voltage, $V_I^{(1)}$ (regulator 1 and 2) | 2.7 | 6 | V |
| Output current, I_O (regulator 1) | 0 | 250 | mA |
| Output current, I_O (regulator 2) | 0 | 125 | mA |
| Output voltage range (for adjustable option) | 1.22 | 5.5 | V |
| Operating junction temperature, T_J | -40 | +125 | °C |

(1) To calculate the minimum input voltage for maximum output current, use the following equation: $V_{I(\min)} = V_{O(\max)} + V_{DO(\max \text{ load})}$.

ELECTRICAL CHARACTERISTICS

Over recommended operating junction temperature range ($T_J = -40^\circ\text{C}$ to $+125^\circ\text{C}$), V_{IN1} or $V_{IN2} = V_{OUT(\text{nom})} + 1\text{V}$, $I_O = 1\text{mA}$, $\overline{\text{EN}} = 0\text{V}$, and $C_O = 33\mu\text{F}$ (unless otherwise noted).

| PARAMETER | | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|---|-----------------------------------|--|--|---------------------------|-------|-------|----------------------------|
| V_O | Reference voltage | $2.7\text{V} < V_I < 6\text{V}$, $T_J = +25^\circ\text{C}$ | FB connected to V_O | | 1.22 | | V |
| | | $2.7\text{V} < V_I < 6\text{V}$, | FB connected to V_O | 1.196 | | 1.244 | |
| | 1.2V Output | $2.7\text{V} < V_I < 6\text{V}$, | $T_J = +25^\circ\text{C}$ | | 1.2 | | |
| | | $2.7\text{V} < V_I < 6\text{V}$, | | 1.176 | | 1.224 | |
| | 1.5V Output | $2.7\text{V} < V_I < 6\text{V}$, | $T_J = +25^\circ\text{C}$ | | 1.5 | | |
| | | $2.7\text{V} < V_I < 6\text{V}$, | | 1.47 | | 1.53 | |
| | 1.8V Output | $2.8\text{V} < V_I < 6\text{V}$, | $T_J = +25^\circ\text{C}$ | | 1.8 | | |
| | | $2.8\text{V} < V_I < 6\text{V}$, | | 1.764 | | 1.836 | |
| | 2.5V Output | $3.5\text{V} < V_I < 6\text{V}$, | $T_J = +25^\circ\text{C}$ | | 2.5 | | |
| | | $3.5\text{V} < V_I < 6\text{V}$, | | 2.45 | | 2.55 | |
| 3.3V Output | $4.3\text{V} < V_I < 6\text{V}$, | $T_J = +25^\circ\text{C}$ | | 3.3 | | | |
| | $4.3\text{V} < V_I < 6\text{V}$, | | 3.234 | | 3.366 | | |
| Quiescent current (GND current) for regulator 1 and regulator 2, $\overline{\text{EN}} = 0\text{V}^{(1)}$ | | ⁽²⁾ | $T_J = +25^\circ\text{C}$ | | 190 | | μA |
| | | ⁽²⁾ | | | | 230 | |
| Output voltage line regulation ($\Delta V_O/V_O$) for regulator 1 and regulator 2 ⁽³⁾ | | $V_O + 1\text{V} < V_I \leq 6\text{V}$, | $T_J = +25^\circ\text{C}^{(1)}$ | | 0.01% | | V |
| | | $V_O + 1\text{V} < V_I \leq 6\text{V}$ | ⁽¹⁾ | | | 0.1% | |
| Load regulation for V_{OUT1} and V_{OUT2} | | $T_J = +25^\circ\text{C}$ | ⁽²⁾ | | 1 | | mV |
| V_n | Output noise voltage | Regulator 1 | $\text{BW} = 300\text{Hz to } 50\text{kHz}$, $C_O = 33\mu\text{F}$, $T_J = +25^\circ\text{C}$ | | 65 | | μV_{RMS} |
| | | Regulator 2 | | | 65 | | |
| Output current limit | | Regulator 1 | $V_{OUT} = 0\text{V}$ | | 1.6 | 1.9 | μA |
| | | Regulator 2 | | | 0.750 | 1 | |
| Thermal shutdown junction temperature | | | | | +150 | | °C |
| I_I (standby) | Standby current | Regulator 1 | $\overline{\text{EN}} = V_I$, | $T_J = +25^\circ\text{C}$ | | 2 | μA |
| | | | $\overline{\text{EN}} = V_I$ | | | 6 | |
| | | Regulator 2 | $\overline{\text{EN}} = V_I$, | $T_J = +25^\circ\text{C}$ | | 2 | μA |
| | | | $\overline{\text{EN}} = V_I$ | | | 6 | |
| PSRR | Power-supply ripple rejection | $f = 1\text{kHz}$, $C_O = 33\mu\text{F}$, | $T_J = +25^\circ\text{C}^{(1)}$ | | 60 | | dB |

(1) Minimum input operating voltage is 2.7V or $V_{O(\text{typ})} + 1\text{V}$, whichever is greater. Maximum input voltage = 6V, minimum output current = 1mA.

(2) $I_O = 1\text{mA}$ to 250mA for Regulator 1 and 1mA to 125mA for Regulator 2.

(3) If $V_O < 1.8\text{V}$ then $V_{I\text{max}} = 6\text{V}$, $V_{I\text{min}} = 2.7\text{V}$: $\text{Line Reg. (mV)} = (\% / \text{V}) \times V_O \frac{(V_{I\text{max}} - 2.7\text{V})}{100} \times 1000$
 If $V_O > 2.5\text{V}$ then $V_{I\text{max}} = 6\text{V}$, $V_{I\text{min}} = V_O + 1\text{V}$: $\text{Line Reg. (mV)} = (\% / \text{V}) \times V_O \frac{(V_{I\text{max}} - (V_O + 1\text{V}))}{100} \times 1000$

ELECTRICAL CHARACTERISTICS (continued)

Over recommended operating junction temperature range ($T_J = -40^\circ\text{C}$ to $+125^\circ\text{C}$), V_{IN1} or $V_{IN2} = V_{OUT(nom)} + 1\text{V}$, $I_O = 1\text{mA}$, $\overline{\text{EN}} = 0\text{V}$, and $C_O = 33\mu\text{F}$ (unless otherwise noted).

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|--|-----------|-----------|-----------|---------------|
| RESET Terminal | | | | | |
| Minimum input voltage for valid $\overline{\text{RESET}}$ | $I_{\overline{\text{RESET}}} = 300\mu\text{A}$, $V_{(\overline{\text{RESET}})} \leq 0.8\text{V}$ | | 1.0 | 1.3 | V |
| Trip threshold voltage | V_O decreasing | 92% | 95% | 98% | V_{OUT} |
| Hysteresis voltage | Measured at V_O | | 0.5% | | V_{OUT} |
| $t_{(\overline{\text{RESET}})}$ | $\overline{\text{RESET}}$ pulse duration | 80 | 120 | 160 | ms |
| $t_{r(\overline{\text{RESET}})}$ | Rising edge deglitch | | 30 | | μs |
| Output low voltage | $V_I = 3.5\text{V}$, $I_{O(\overline{\text{RESET}})} = 1\text{mA}$ | | 0.15 | 0.4 | V |
| Leakage current | $V_{(\overline{\text{RESET}})} = 6\text{V}$ | | | 1 | μA |
| PG1 Terminal | | | | | |
| Minimum input voltage for valid PG1 | $I_{(\text{PG1})} = 300\mu\text{A}$, $V_{(\text{PG1})} \leq 0.8\text{V}$ | | 1.0 | 1.3 | V |
| Trip threshold voltage | V_O decreasing | 92% | 95% | 98% | V_{OUT} |
| Hysteresis voltage | Measured at V_O | | 0.5% | | V_{OUT} |
| $t_{f(\text{PG1})}$ | Falling edge deglitch | | 30 | | μs |
| Output low voltage | $V_I = 2.7\text{V}$, $I_{O(\text{PG1})} = 1\text{mA}$ | | 0.15 | 0.4 | V |
| Leakage current | $V_{(\text{PG1})} = 6\text{V}$ | | | 1 | μA |
| EN Terminal | | | | | |
| High level $\overline{\text{EN}}$ input voltage | | 2 | | | V |
| Low level $\overline{\text{EN}}$ input voltage | | | | 0.7 | V |
| Input current ($\overline{\text{EN}}$) | | -1 | | 1 | μA |
| SEQ Terminal | | | | | |
| High level SEQ input voltage | | 2 | | | V |
| Low level SEQ input voltage | | | | 0.7 | V |
| Falling edge delay | Measured at V_O | | 140 | | μs |
| SEQ pull-up current source | | | 6 | | μA |
| MR1 / MR2 Terminals | | | | | |
| High level input voltage | | 2 | | | V |
| Low level input voltage | | | | 0.7 | V |
| Pull-up current source | | | 6 | | μA |
| V_{OUT2} Terminal | | | | | |
| V_{OUT2} UV comparator: Positive-going input threshold voltage of V_{OUT2} UV comparator | | 80% V_O | 83% V_O | 86% V_O | V |
| V_{OUT2} UV comparator: Falling edge deglitch | V_{SENSE_2} decreasing below threshold | | 140 | | μs |
| Peak output current | 2ms pulse width | | 375 | | mA |
| Discharge transistor current | $V_{OUT2} = 1.5\text{V}$ | | 7.5 | | mA |

ELECTRICAL CHARACTERISTICS (continued)

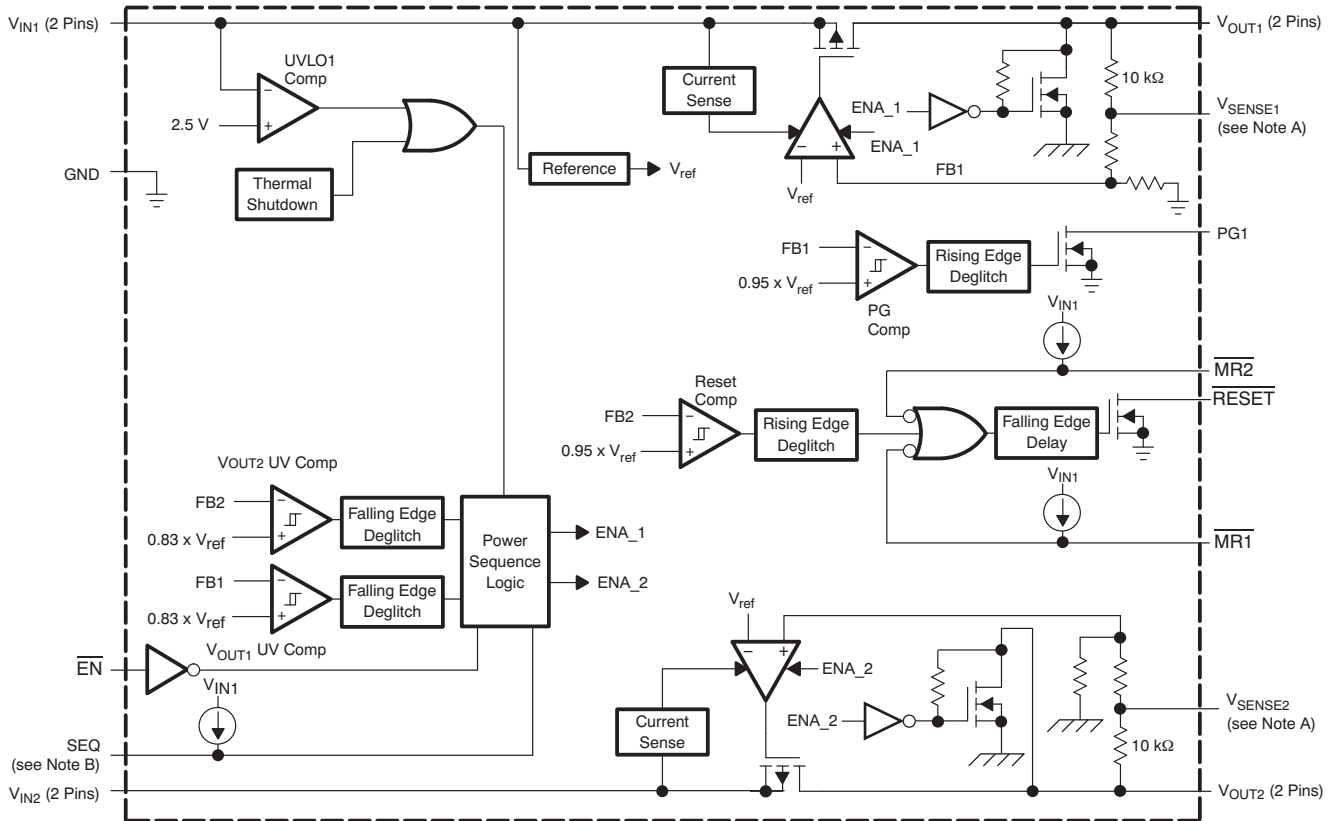
Over recommended operating junction temperature range ($T_J = -40^\circ\text{C}$ to $+125^\circ\text{C}$), V_{IN1} or $V_{IN2} = V_{OUT(nom)} + 1\text{V}$, $I_O = 1\text{mA}$, $\overline{\text{EN}} = 0\text{V}$, and $C_O = 33\mu\text{F}$ (unless otherwise noted).

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---|---------------------|--------------------|--------------------|------|
| V_{OUT1} Terminal | | | | | |
| V _{OUT1} UV comparator: Positive-going input threshold voltage of V _{OUT1} UV comparator | | 80% V _O | 83% V _O | 86% V _O | V |
| V _{OUT1} UV comparator: Hysteresis | | 0.5% V _O | | | mV |
| V _{OUT1} UV comparator: Falling edge deglitch | V _{SENSE_1} decreasing below threshold | 140 | | | μs |
| Dropout voltage ⁽⁴⁾ | I _O = 250mA, T _J = +25°C V _{IN1} = 3.2V | 83 | | | mV |
| Dropout voltage ⁽⁴⁾ | I _O = 250mA, V _{IN1} = 3.2V | 140 | | | mV |
| Peak output current ⁽⁴⁾ | 2ms pulse width | 750 | | | mA |
| Discharge transistor current | V _{OUT1} = 1.5V | 7.5 | | | mA |
| V _{IN1} UVLO threshold | | 2.4 | 2.65 | | V |
| FB Terminal | | | | | |
| Input current: TPS70702 | FB = 1.8V | 1 | | | μA |

(4) Input voltage (V_{IN1} or V_{IN2}) = $V_{O(typ)} - 100\text{mV}$. For 1.5V, 1.8V and 2.5V regulators, the dropout voltage is limited by input voltage range. The 3.3V regulator input is set to 3.2V to perform this test.

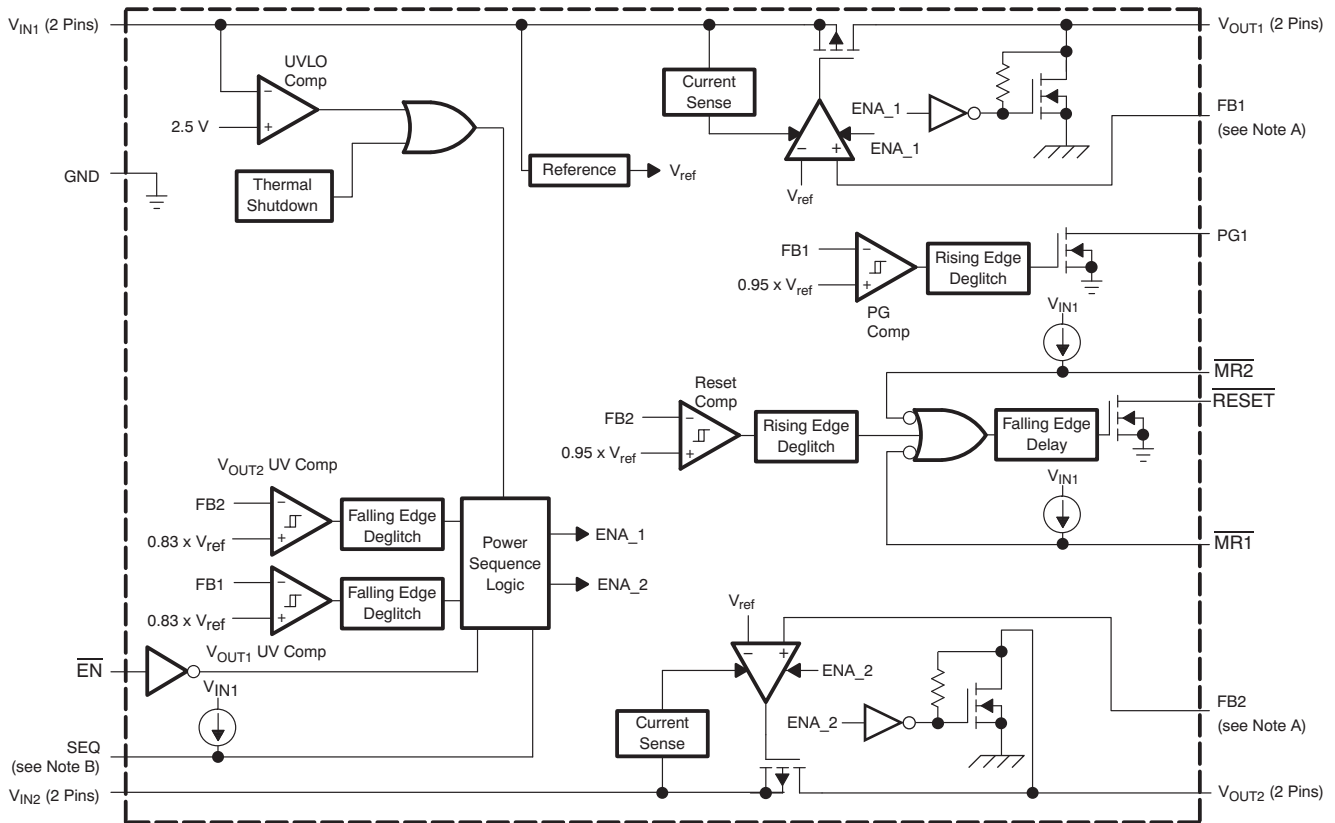
DEVICE INFORMATION

Fixed Voltage Version



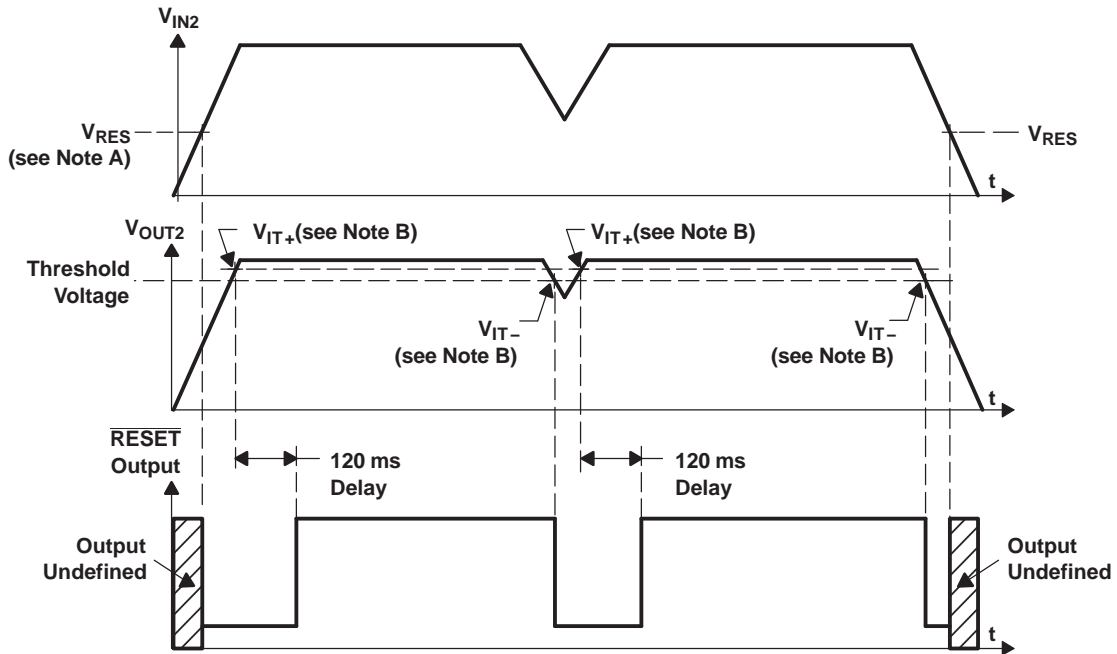
- A. For most applications, V_{SENSE1} and V_{SENSE2} should be externally connected to V_{OUT} as close as possible to the device. For other implementations, refer to SENSE terminal connection discussion in the [Application Information](#) section.
- B. If the SEQ terminal is floating at the input, V_{OUT2} powers up first.

Adjustable Voltage Version



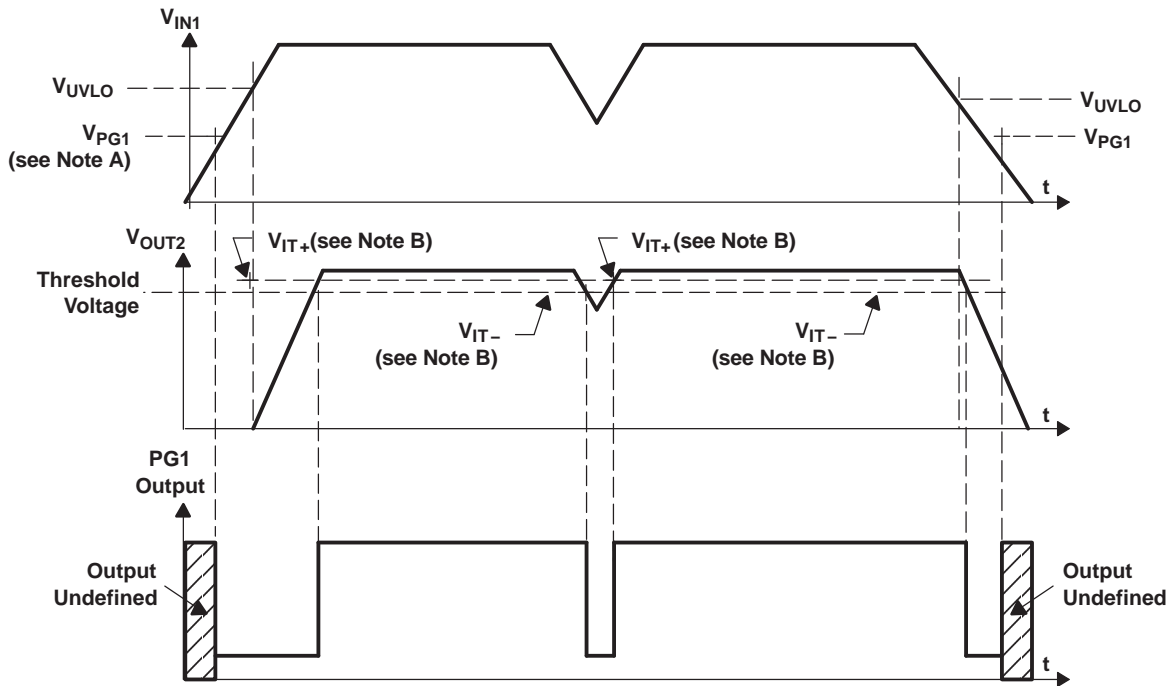
- A. For most applications, FB1 and FB2 should be externally connected to resistor dividers as close as possible to the device. For other implementations, refer to FB terminals connection discussion in the [Application Information](#) section.
- B. If the SEQ terminal is floating at the input, V_{OUT2} powers up first

RESET Timing Diagram (with V_{IN1} Powered Up)



- NOTES: A. V_{RES} is the minimum input voltage for a valid \overline{RESET} . The symbol V_{RES} is not currently listed within EIA or JEDEC standards for semiconductor symbology.
- B. V_{IT-} Trip voltage is typically 5% lower than the output voltage ($95\%V_O$) V_{IT-} to V_{IT+} is the hysteresis voltage.

PG1 Timing Diagram



- NOTES: A. V_{PG1} is the minimum input voltage for a valid PG1. The symbol V_{PG1} is not currently listed within EIA or JEDEC standards for semiconductor symbology.
- B. V_{IT-} Trip voltage is typically 5% lower than the output voltage ($95\%V_O$) V_{IT-} to V_{IT+} is the hysteresis voltage.

Table 1. TERMINAL FUNCTIONS

| TERMINAL | | I/O | DESCRIPTION |
|--------------------------------|-----------|-----|--|
| NAME | NO. | | |
| $\overline{\text{EN}}$ | 6 | I | Active low enable |
| GND | 8 | — | Ground |
| $\overline{\text{MR1}}$ | 4 | I | Manual reset input 1, active low, pulled up internally |
| $\overline{\text{MR2}}$ | 5 | I | Manual reset input 2, active low, pulled up internally |
| NC | 1, 11, 20 | — | No connection |
| PG1 | 16 | O | Open drain output, low when V_{OUT1} voltage is less than 95% of the nominal regulated voltage |
| $\overline{\text{RESET}}$ | 15 | O | Open drain output, SVS (power-on reset) signal, active low |
| SEQ | 7 | I | Power-up sequence control: SEQ = High, V_{OUT2} powers up first; SEQ = Low, V_{OUT1} powers up first, SEQ terminal pulled up internally. |
| V_{IN1} | 2, 3 | I | Input voltage of regulator 1 |
| V_{IN2} | 9, 10 | I | Input voltage of regulator 2 |
| V_{OUT1} | 18, 19 | O | Output voltage of regulator 1 |
| V_{OUT2} | 12, 13 | O | Output voltage of regulator 2 |
| $V_{\text{SENSE2}}/\text{FB2}$ | 14 | I | Regulator 2 output voltage sense/regulator 2 feedback for adjustable |
| $V_{\text{SENSE1}}/\text{FB1}$ | 17 | I | Regulator 1 output voltage sense/regulator 1 feedback for adjustable |

Detailed Description

The TPS707xx low dropout regulator family provides dual regulated output voltages for DSP applications that require high-performance power management solutions. These devices provide fast transient response and high accuracy with small output capacitors, while drawing low quiescent current. Programmable sequencing provides a power solution for DSPs without any external component requirements. This architecture reduces the component cost and board space while increasing total system reliability. The TPS707xx family has an enable feature that puts the device in sleep mode, reducing the input currents to less than 3 μ A. Other features are integrated SVS (Power-On Reset, $\overline{\text{RESET}}$) and Power Good (PG1) that monitor output voltages and provide logic output to the system. These differentiated features provide a complete DSP power solution.

The TPS707xx, unlike many other LDOs, feature very low quiescent current that remains virtually constant even with varying loads. Conventional LDO regulators use a pnp pass element, the base current of which is directly proportional to the load current through the regulator ($I_B = I_C/\beta$). The TPS707xx uses a PMOS transistor to pass current; because the gate of the PMOS is voltage-driven, operating current is low and stable over the full load range.

Pin Functions

Enable

The $\overline{\text{EN}}$ terminal is an input that enables or shuts down the device. If $\overline{\text{EN}}$ is at a voltage high signal, the device is in shutdown mode. When $\overline{\text{EN}}$ goes to voltage low, the device is enabled.

Sequence

The SEQ terminal is an input that programs which output voltage (V_{OUT1} or V_{OUT2}) turns on first. When the device is enabled and the SEQ terminal is pulled high or left open, V_{OUT2} turns on first and V_{OUT1} remains off until V_{OUT2} reaches approximately 83% of its regulated output voltage. At that time, V_{OUT1} is turned on. If V_{OUT2} is pulled below 83% (for example, in an overload condition) V_{OUT1} is turned off. These terminals have a 6- μ A pullup current to V_{IN1} .

Pulling the SEQ terminal low reverses the power-up order and V_{OUT1} is turned on first. For detailed timing diagrams, refer to [Figure 36](#) through [Figure 40](#).

Power-Good

The PG1 is an open drain, active high output terminal that indicates the status of the V_{OUT1} regulator. When the V_{OUT1} reaches 95% of its regulated voltage, PG1 goes to a high impedance state. It goes to a low impedance state when it is pulled below 95% (for example, doing an overload condition) of its regulated voltage. The open drain output of the PG1 terminal requires a pull-up resistor.

Manual Reset Pins ($\overline{MR1}$ and $\overline{MR2}$)

$\overline{MR1}$ and $\overline{MR2}$ are active low input terminals used to trigger a reset condition. When either $\overline{MR1}$ or $\overline{MR2}$ is pulled to logic low, a POR (\overline{RESET}) occurs. These terminals have a 6- μ A pull-up current to V_{IN1} .

Sense (V_{SENSE1} , V_{SENSE2})

The sense terminals of fixed-output options must be connected to the regulator output, and the connection should be as short as possible. Internally, sense connects to high-impedance, wide-bandwidth amplifiers through a resistor-divider network and noise pickup feeds through to the regulator output. It is essential to route the sense connection in such a way to minimize or avoid noise pickup. Adding RC networks between the V_{SENSE} terminals and V_{OUT} terminals to filter noise is not recommended because these networks can cause the regulators to oscillate.

FB1 and FB2

FB1 and FB2 are input terminals used for adjustable-output devices and must be connected to the external feedback resistor divider. FB1 and FB2 connections should be as short as possible. It is essential to route them in such a way as to minimize or avoid noise pickup. Adding RC networks between the FB terminals and V_{OUT} terminals to filter noise is not recommended because these networks can cause the regulators to oscillate.

\overline{RESET} Indicator

The TPS707xx features a \overline{RESET} (SVS, POR, or Power-On Reset). \overline{RESET} can be used to drive power-on reset circuitry or a low-battery indicator. \overline{RESET} is an active low, open drain output that indicates the status of the V_{OUT2} regulator and both manual reset pins ($\overline{MR1}$ and $\overline{MR2}$). When V_{OUT2} exceeds 95% of its regulated voltage, and $\overline{MR1}$ and $\overline{MR2}$ are in the high impedance state, \overline{RESET} goes to a high-impedance state after 120ms delay. \overline{RESET} goes to a low-impedance state when V_{OUT2} is pulled below 95% (for example, an overload condition) of its regulated voltage. To monitor V_{OUT1} , the PG1 output pin can be connected to $\overline{MR1}$ or $\overline{MR2}$. The open drain output of the \overline{RESET} terminal requires a pullup resistor. If \overline{RESET} is not used, it can be left floating.

V_{IN1} and V_{IN2}

V_{IN1} and V_{IN2} are input to the regulators. **Internal bias voltages are powered by V_{IN1} .**

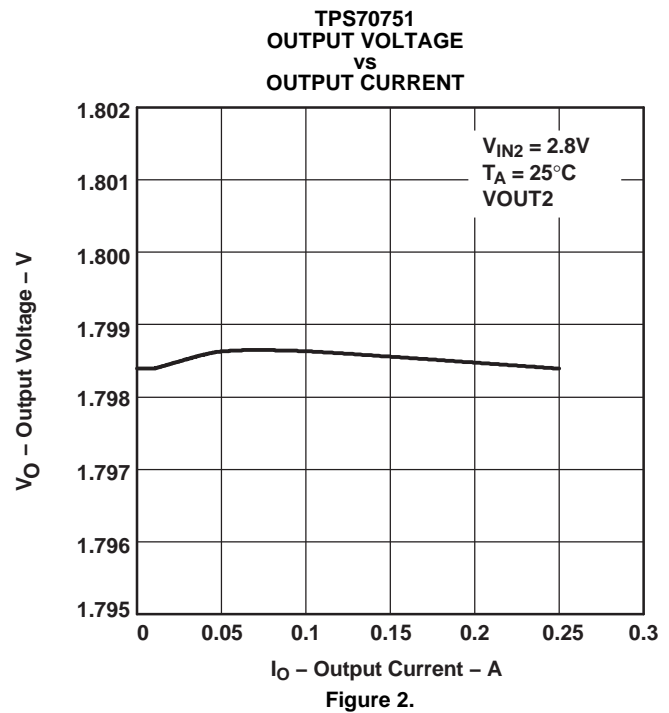
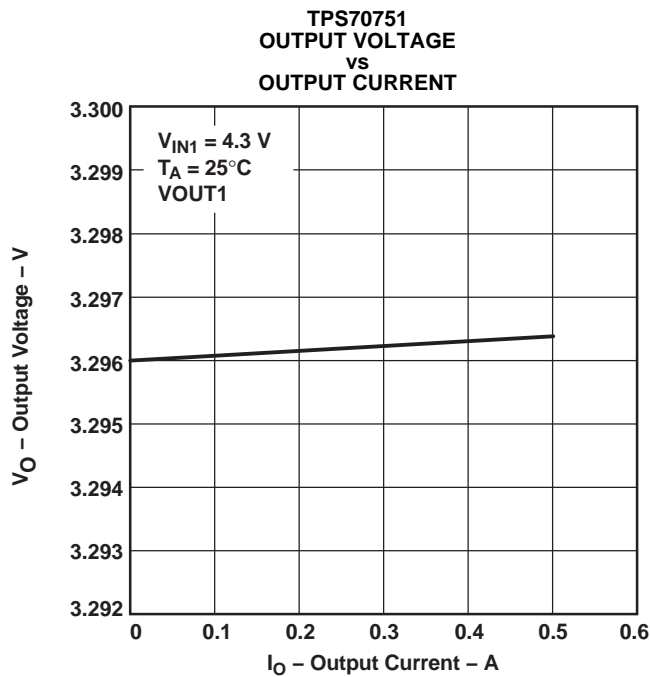
V_{OUT1} and V_{OUT2}

V_{OUT1} and V_{OUT2} are output terminals of the LDO.

TYPICAL CHARACTERISTICS

Table 2. Table of Graphs

| | | | FIGURE |
|--|-----------------------------------|-------------------------|-------------------------|
| V_O | Output voltage | vs Output current | Figure 1 to Figure 3 |
| | | vs Temperature | Figure 4 to Figure 7 |
| | Ground current | vs Junction temperature | Figure 8 |
| PSRR | Power-supply rejection ratio | vs Frequency | Figure 9 to Figure 12 |
| | Output spectral noise density | vs Frequency | Figure 13 to Figure 16 |
| Z_O | Output impedance | vs Frequency | Figure 17 to Figure 20 |
| | | vs Temperature | Figure 21 and Figure 22 |
| | Dropout voltage | vs Input voltage | Figure 23 and Figure 24 |
| | Load transient response | | Figure 25 and Figure 26 |
| | Line transient response | | Figure 27 and Figure 28 |
| V_O | Output voltage and enable voltage | vs Time (start-up) | Figure 29 and Figure 30 |
| | Equivalent series resistance | vs Output current | Figure 31 to Figure 34 |
| Test circuit for typical regions of stability (equivalent series resistance) performance | | | Figure 35 |



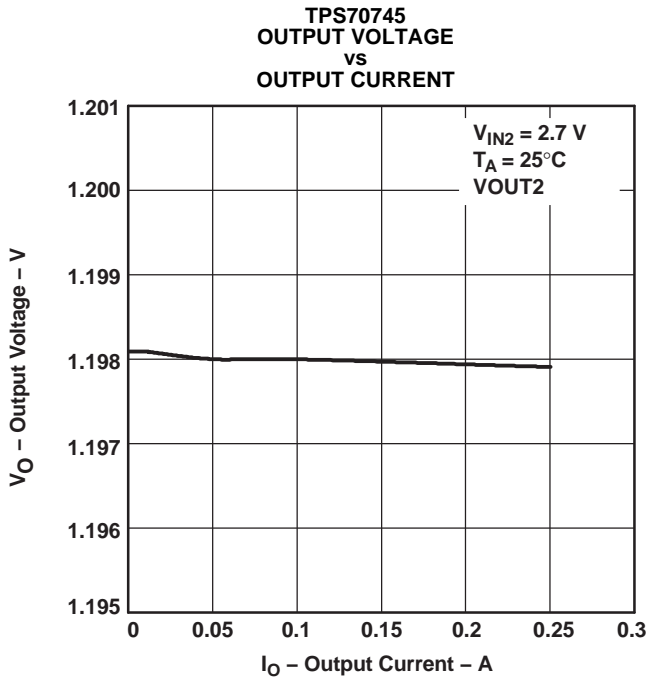


Figure 3.

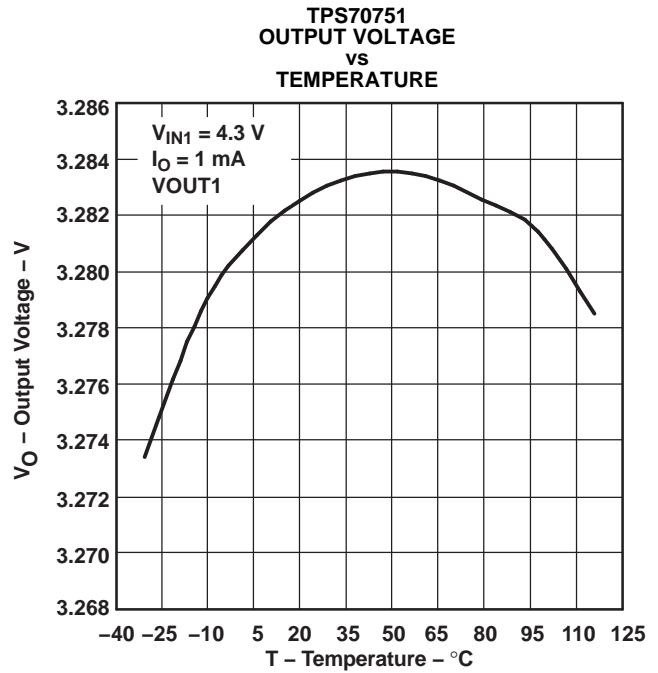


Figure 4.

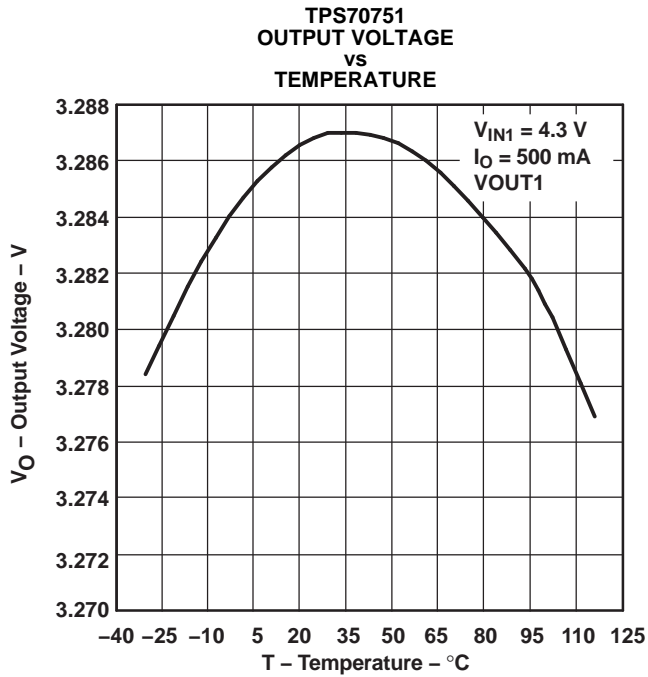


Figure 5.

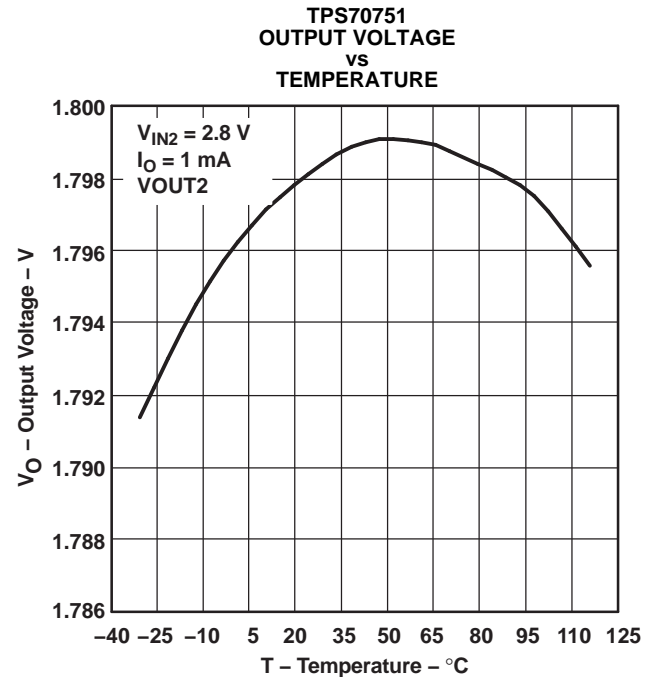


Figure 6.

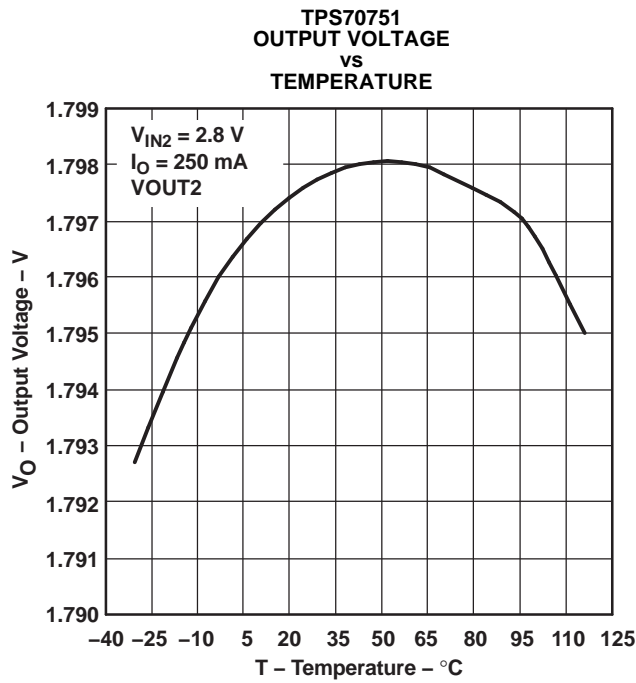


Figure 7.

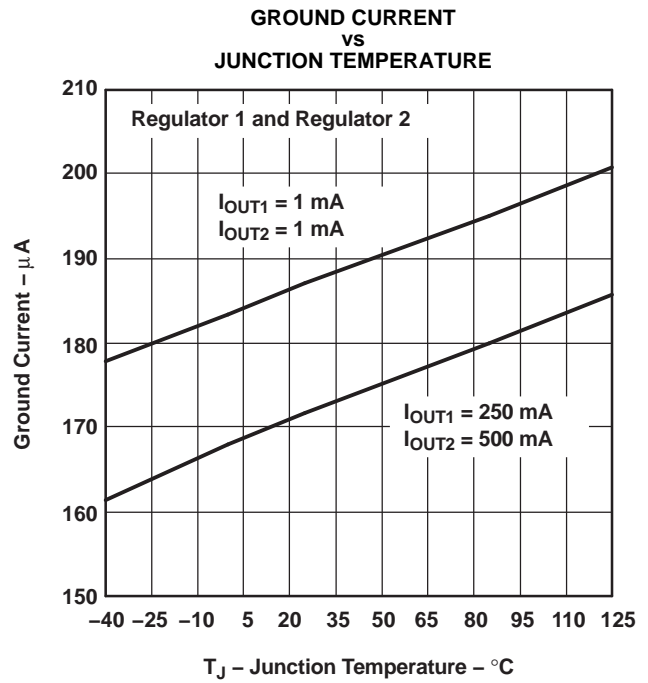


Figure 8.

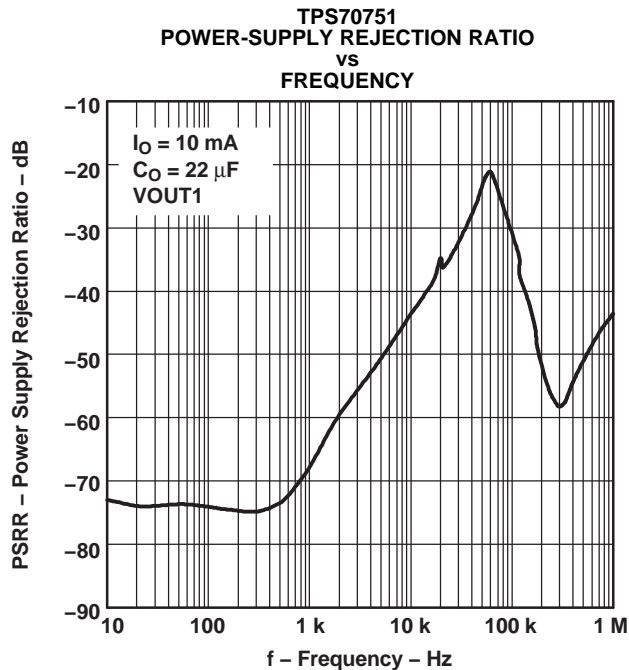


Figure 9.

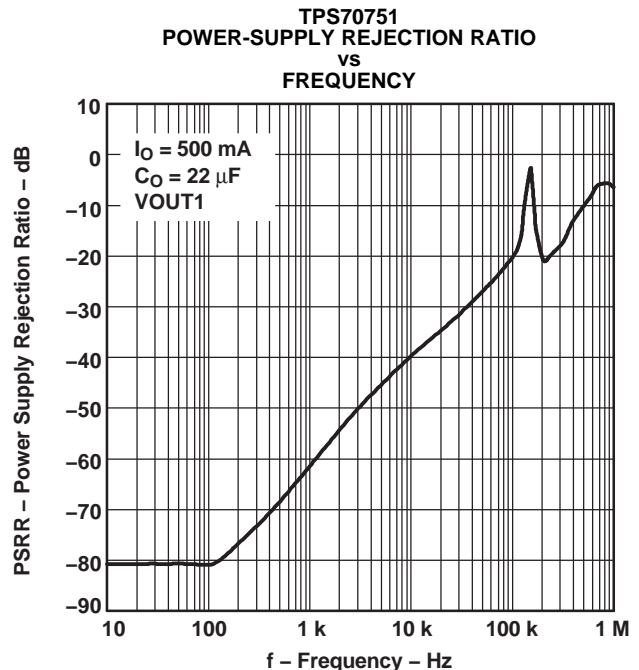


Figure 10.

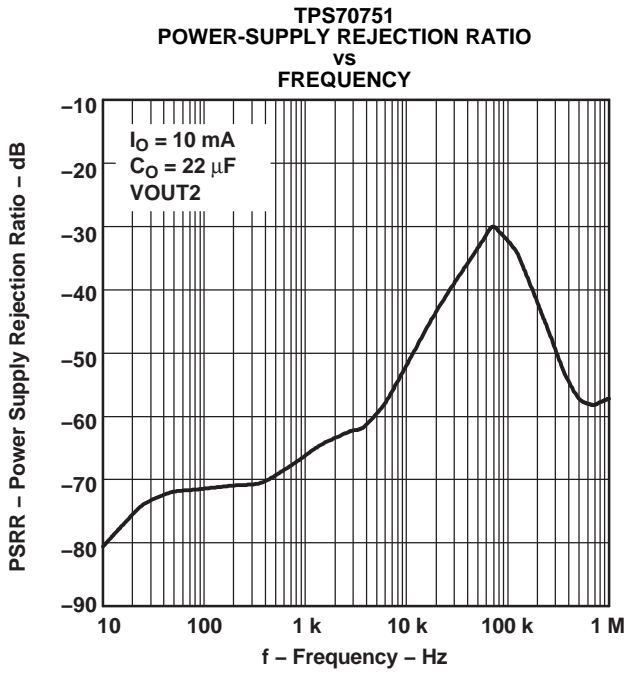


Figure 11.

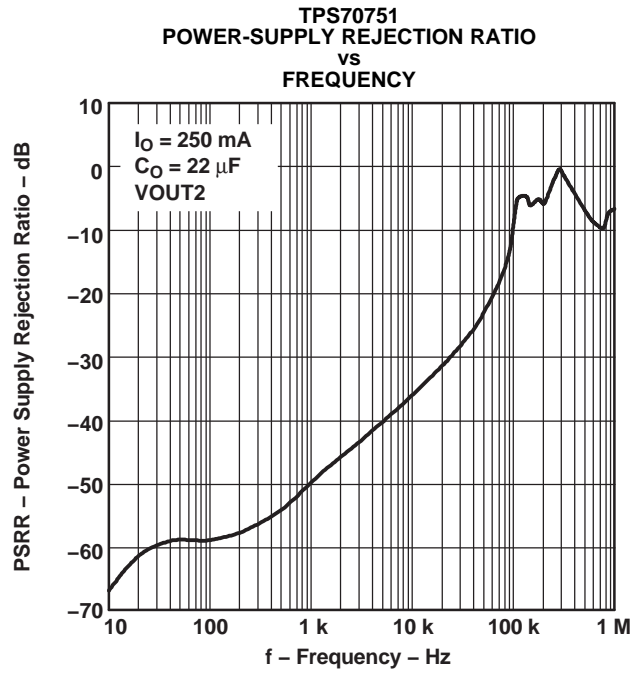


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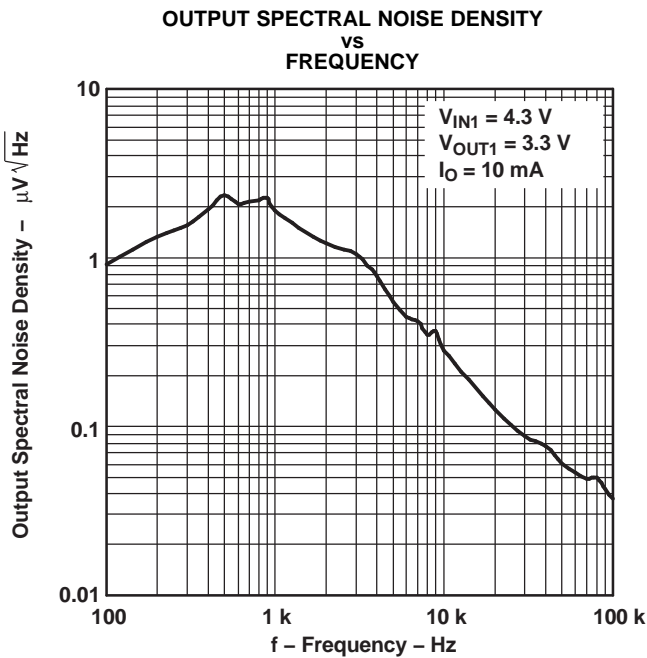


Figure 13.

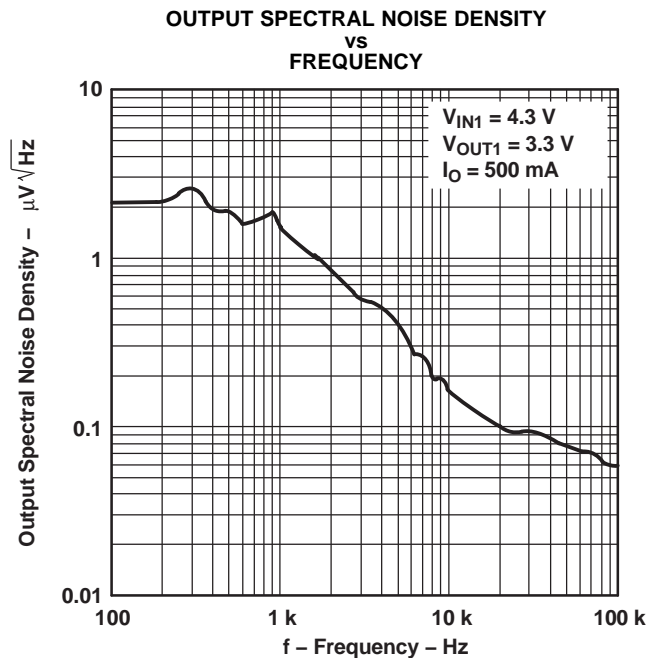


Figure 14.

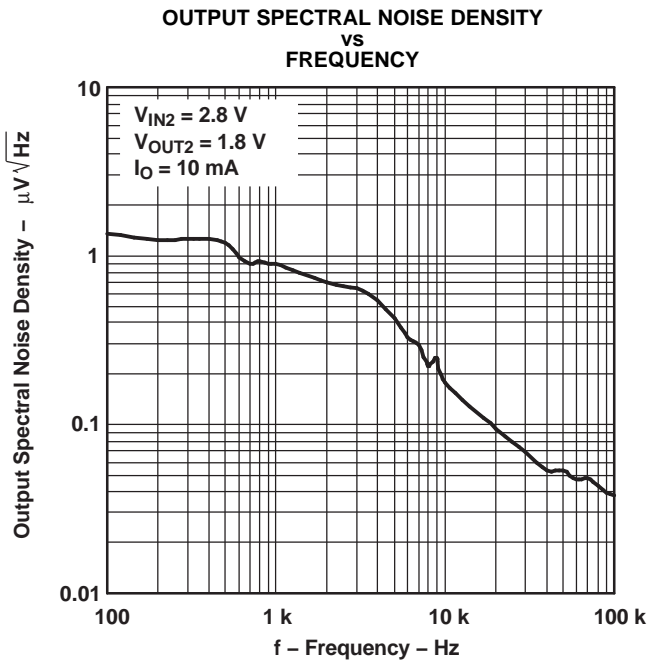


Figure 15.

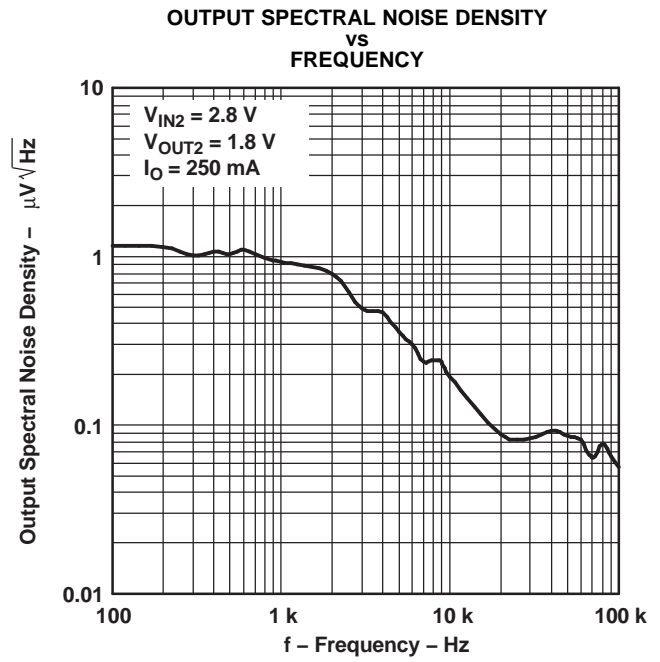


Figure 16.

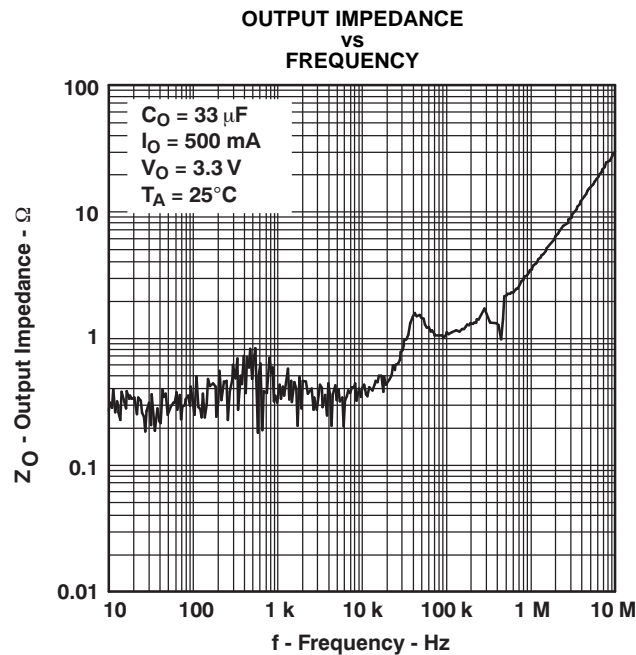


Figure 17.

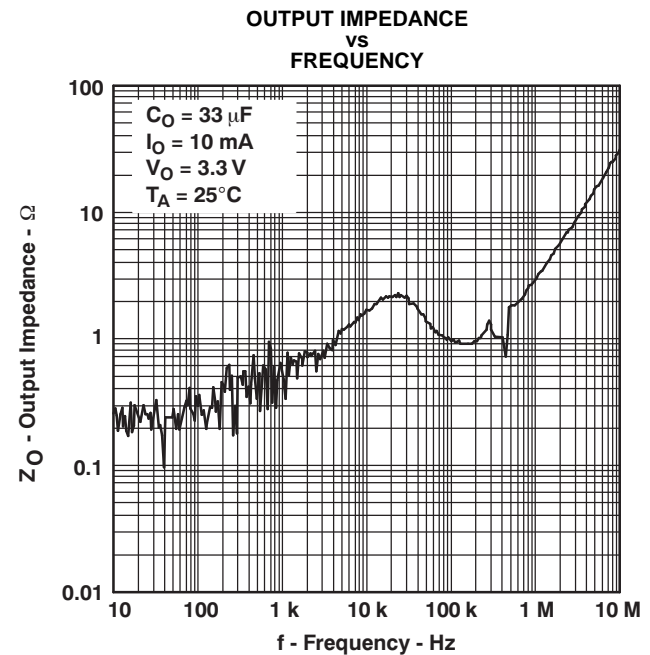


Figure 18.

**OUTPUT IMPEDANCE
vs
FREQUENCY**

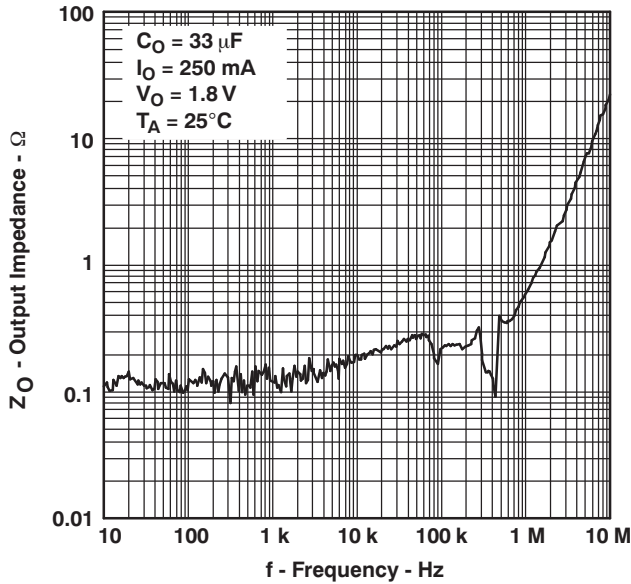


Figure 19.

**OUTPUT IMPEDANCE
vs
FREQUENCY**

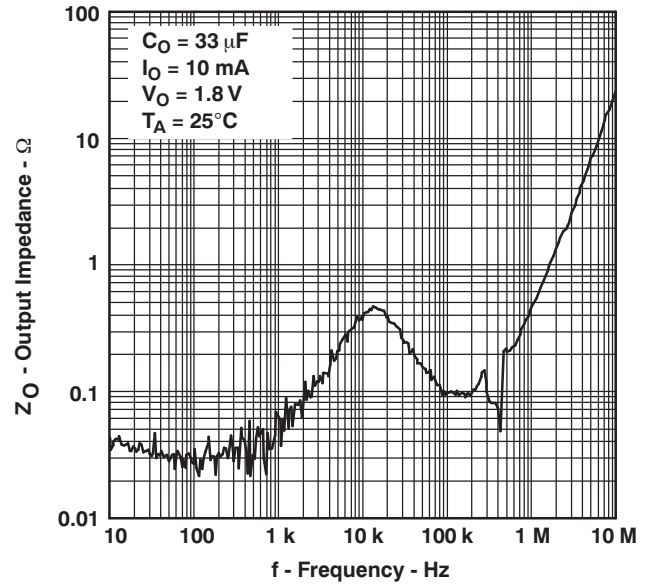


Figure 20.

**DROPOUT VOLTAGE
vs
TEMPERATURE**

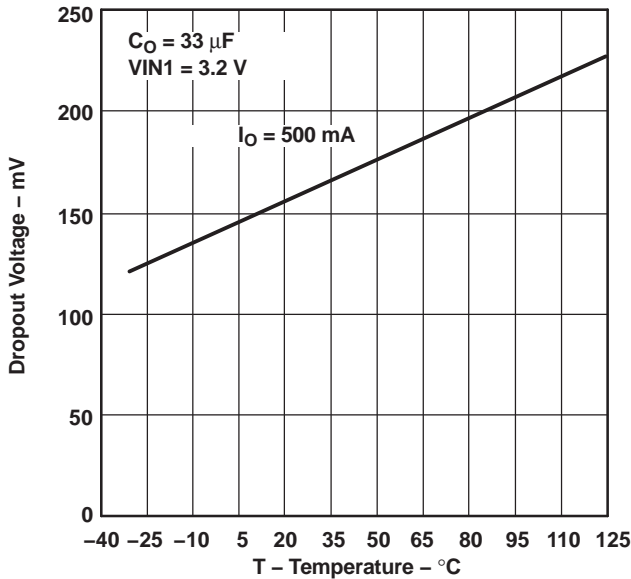


Figure 21.

**DROPOUT VOLTAGE
vs
TEMPERATURE**

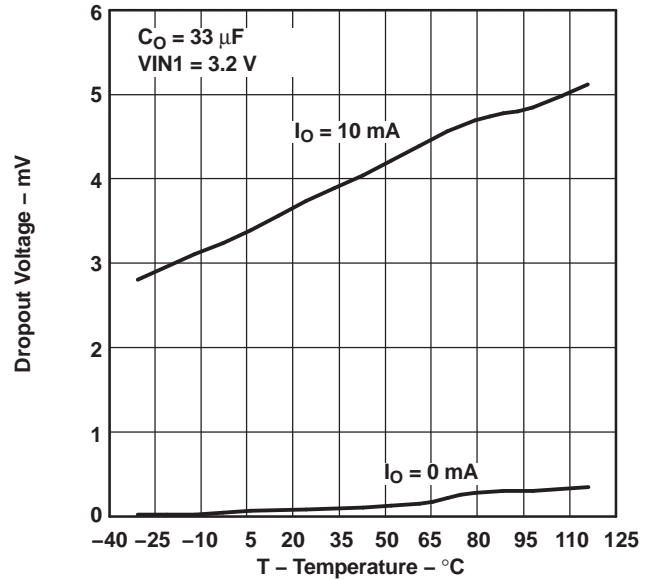


Figure 22.

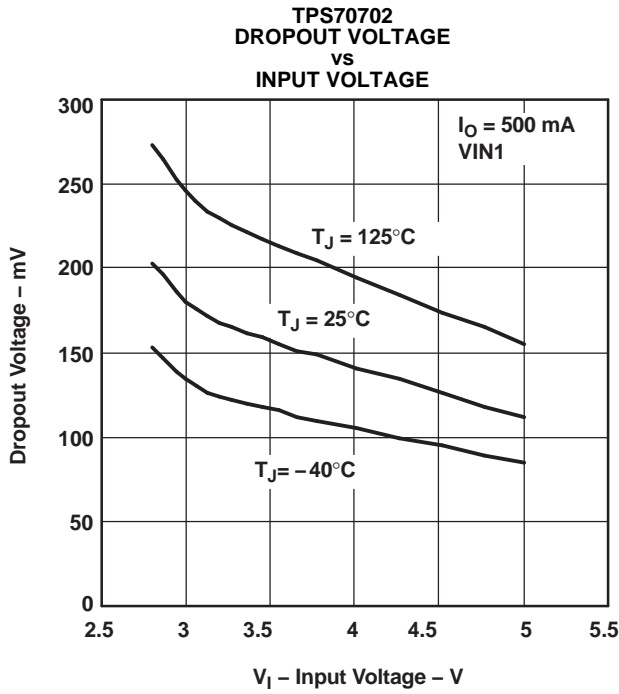


Figure 23.

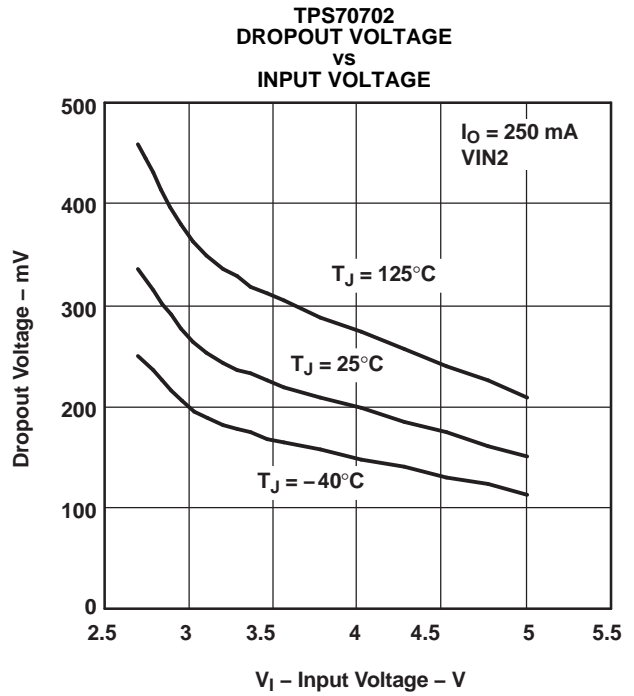


Figure 24.

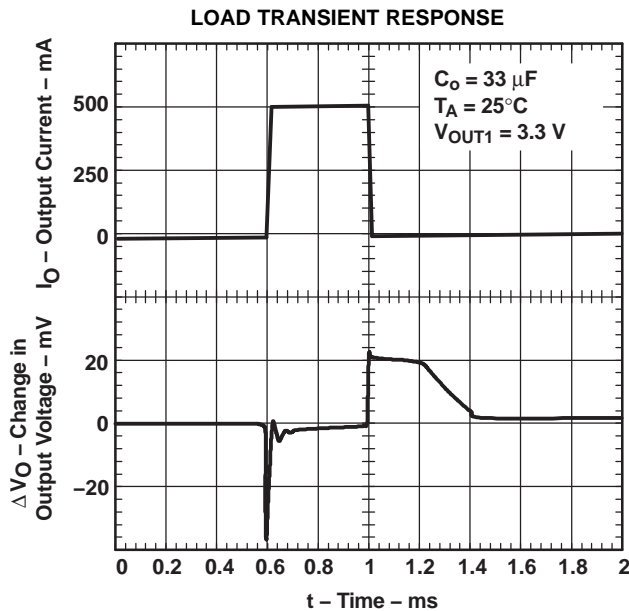


Figure 25.

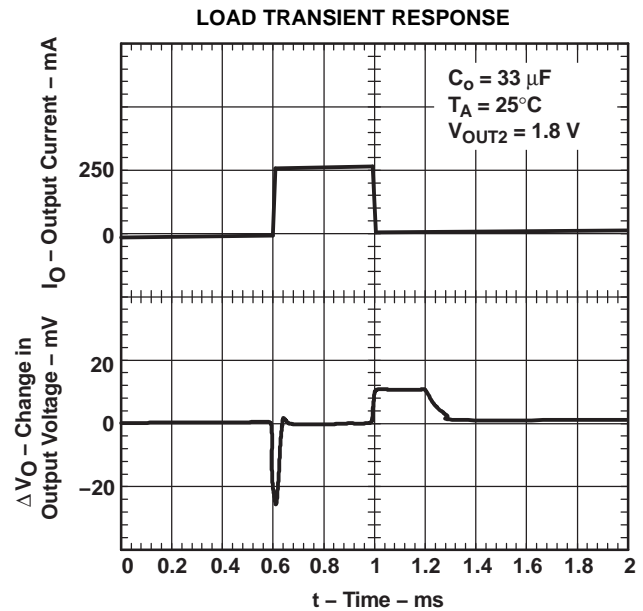


Figure 26.

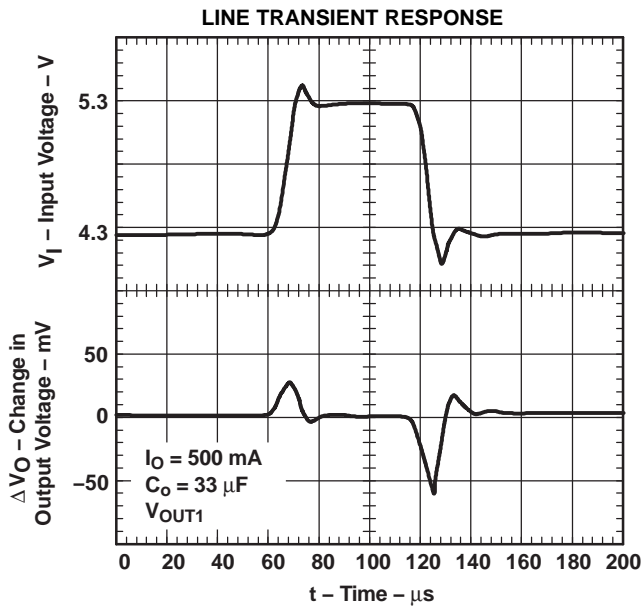


Figure 27.

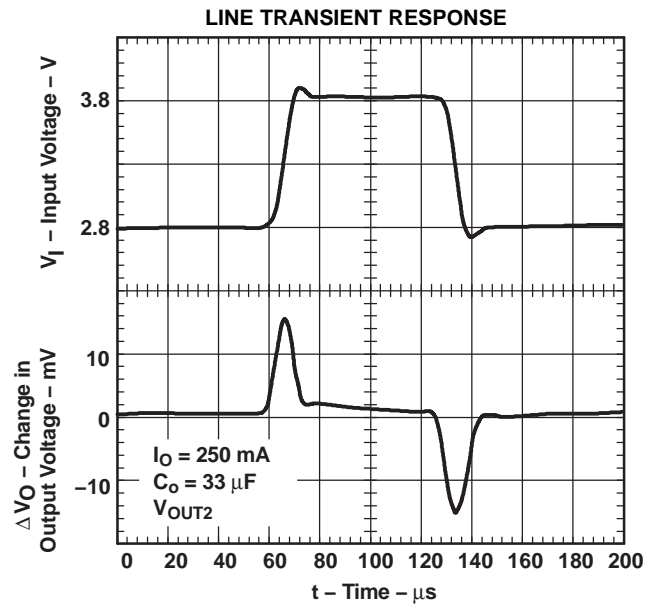


Figure 28.

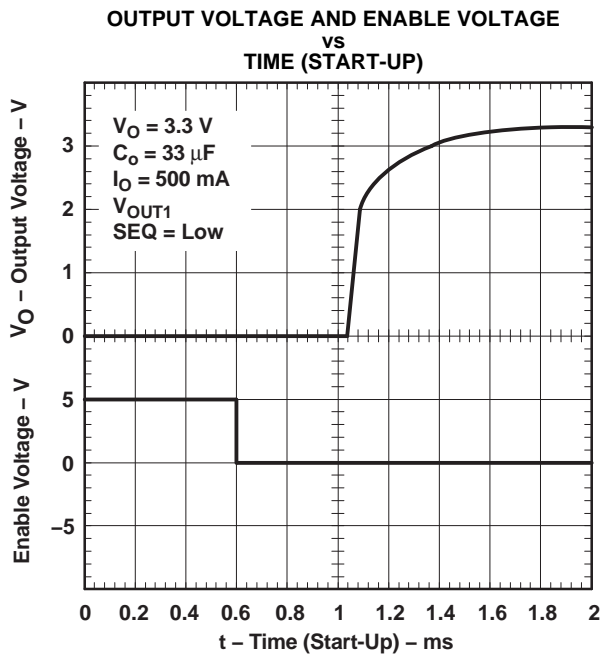


Figure 29.

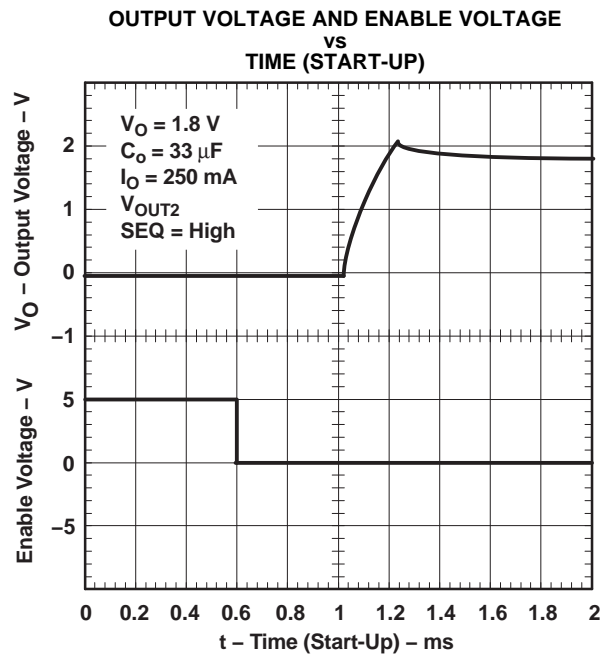
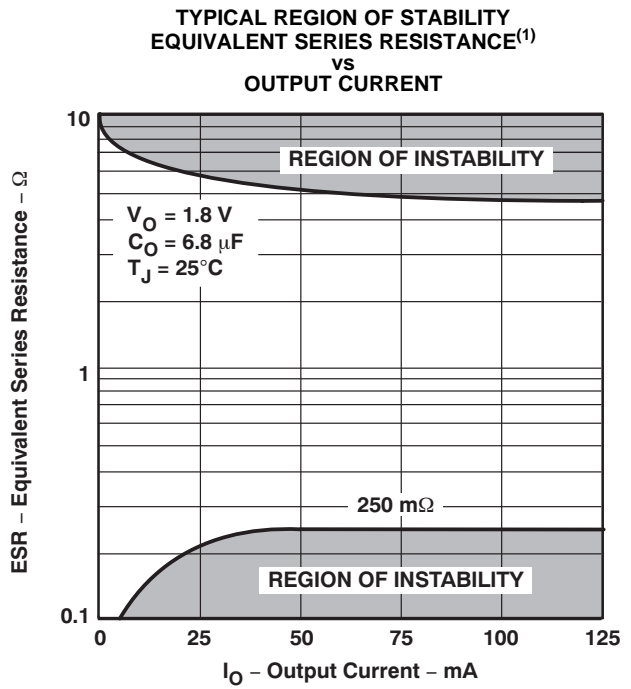
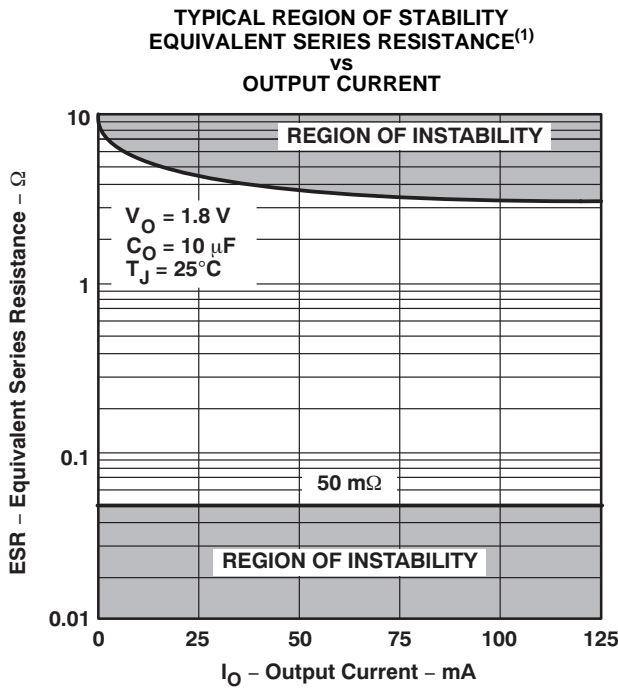
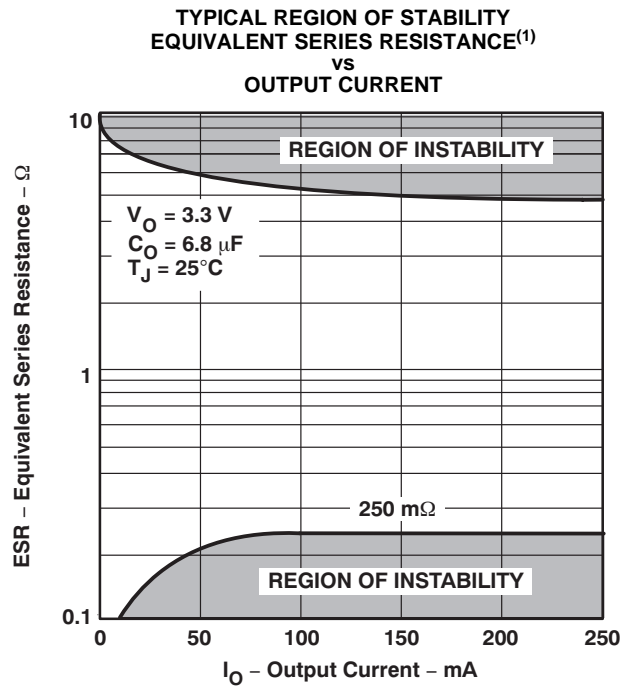
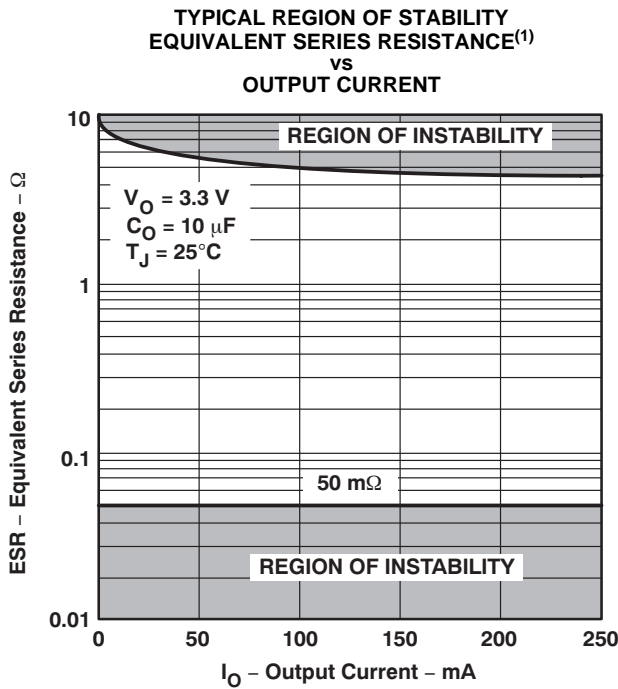


Figure 30.



⁽¹⁾ Equivalent series resistance (ESR) refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to C_O .

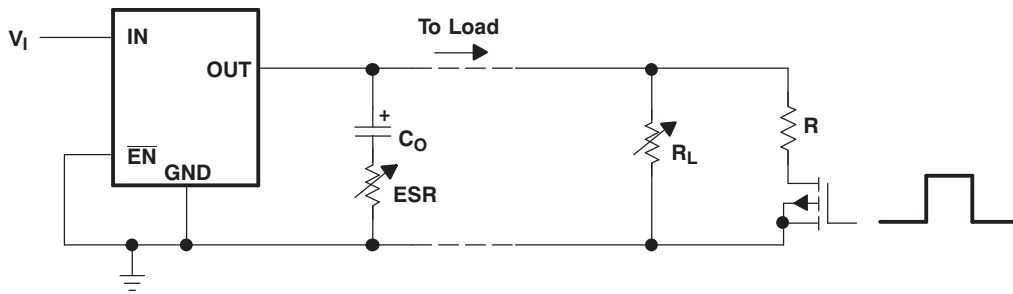


Figure 35. Test Circuit for Typical Regions of Stability

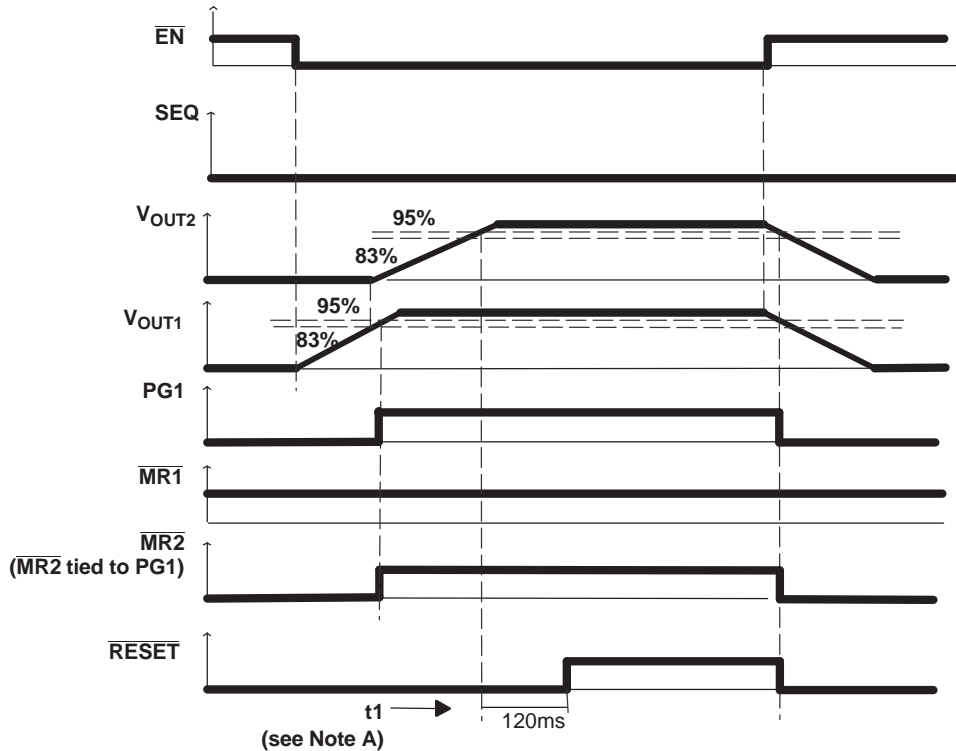
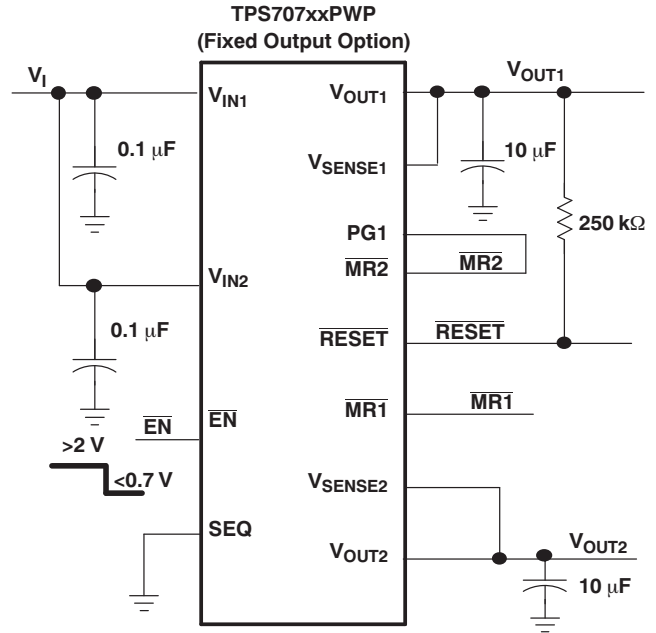
APPLICATION INFORMATION

Sequencing Timing Diagrams

This section provides a number of timing diagrams showing how this device functions in different configurations.

Application condition: V_{IN1} and V_{IN2} are tied to the same fixed input voltage greater than the V_{UVLO} ; SEQ is tied to logic low; PG1 is tied to $\overline{MR2}$; $\overline{MR1}$ is left unconnected and is therefore at logic high.

\overline{EN} is initially high; therefore, both regulators are off and PG1 and \overline{RESET} are at logic low. With SEQ at logic low, when \overline{EN} is taken to logic low, V_{OUT1} turns on. V_{OUT2} turns on after V_{OUT1} reaches 83% of its regulated output voltage. When V_{OUT1} reaches 95% of its regulated output voltage, PG1 (tied to $\overline{MR2}$) goes to logic high. When both V_{OUT1} and V_{OUT2} reach 95% of their respective regulated output voltages and both $\overline{MR1}$ and $\overline{MR2}$ (tied to PG1) are at logic high, \overline{RESET} is pulled to logic high after a 120ms delay. When \overline{EN} is returned to logic high, both devices power down and both PG1 (tied to $\overline{MR2}$) and \overline{RESET} return to logic low.

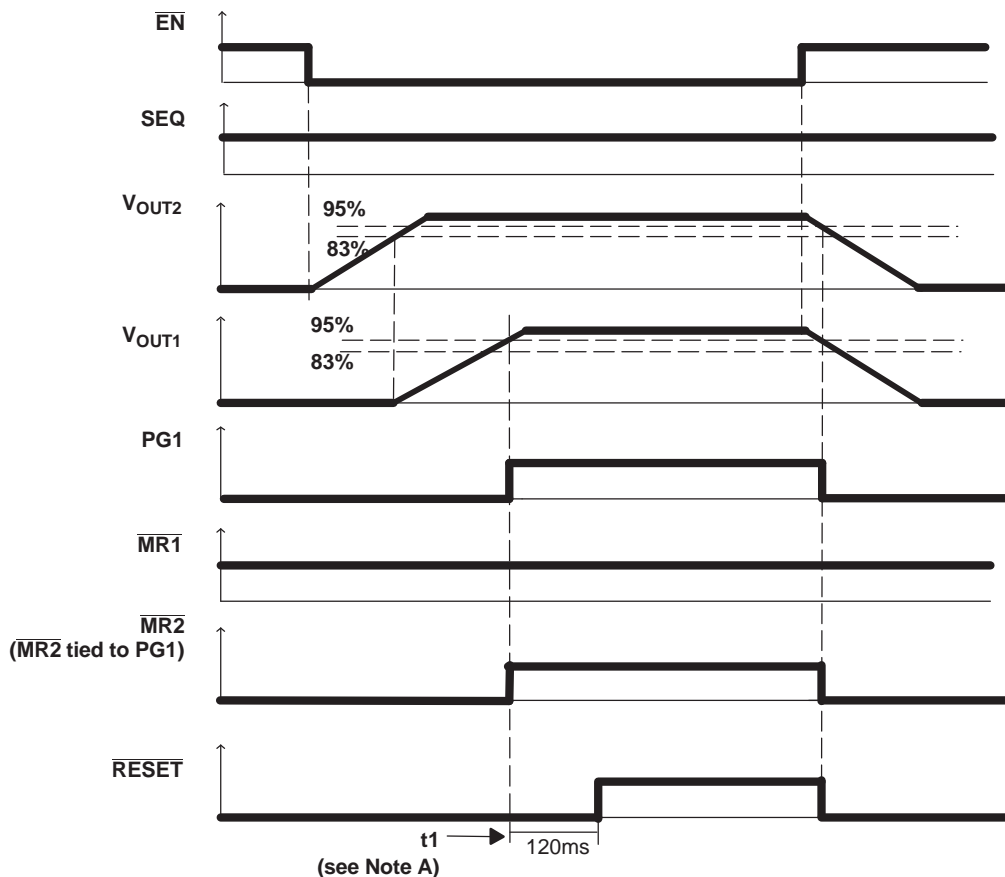
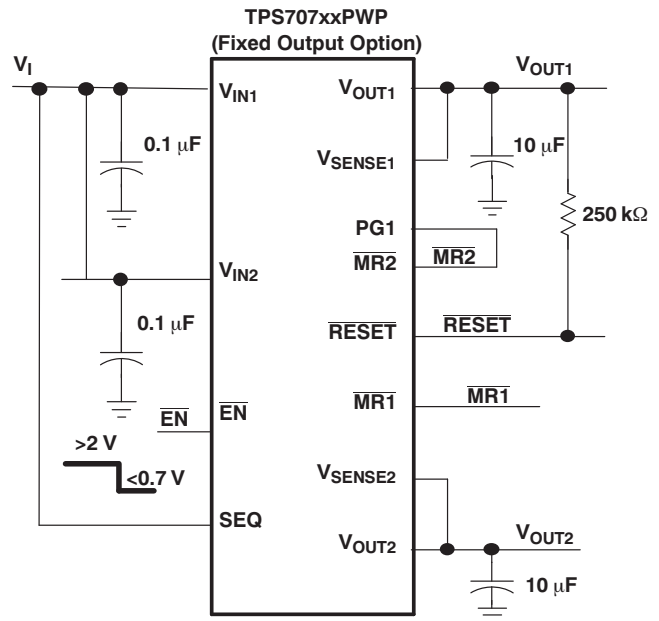


NOTE A: t_1 – Time at which both V_{OUT1} and V_{OUT2} are greater than the PG1 thresholds and $\overline{MR1}$ is logic high.

Figure 36. Timing when SEQ = Low

Application condition: V_{IN1} and V_{IN2} are tied to the same fixed input voltage greater than the V_{UVLO} ; SEQ is tied to logic high; PG1 is tied to MR2; MR1 is left unconnected and is therefore at logic high.

\overline{EN} is initially high; therefore, both regulators are off and PG1 and RESET are at logic low. With SEQ at logic high, when \overline{EN} is taken to logic low, V_{OUT2} turns on. V_{OUT1} turns on after V_{OUT2} reaches 83% of its regulated output voltage. When V_{OUT1} reaches 95% of its regulated output voltage, PG1 (tied to MR2) goes to logic high. When both V_{OUT1} and V_{OUT2} reach 95% of their respective regulated output voltages and both MR1 and MR2 (tied to PG1) are at logic high, RESET is pulled to logic high after a 120ms delay. When \overline{EN} is returned to logic high, both devices turn off and both PG1 (tied to MR2) and RESET return to logic low.

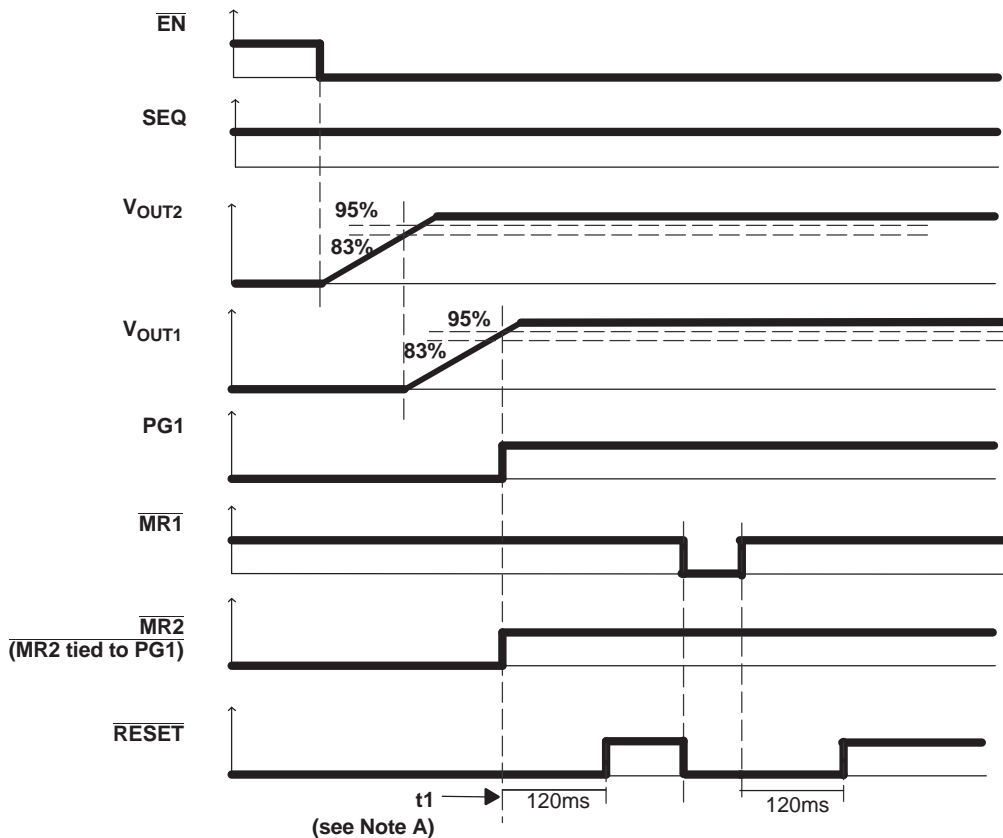
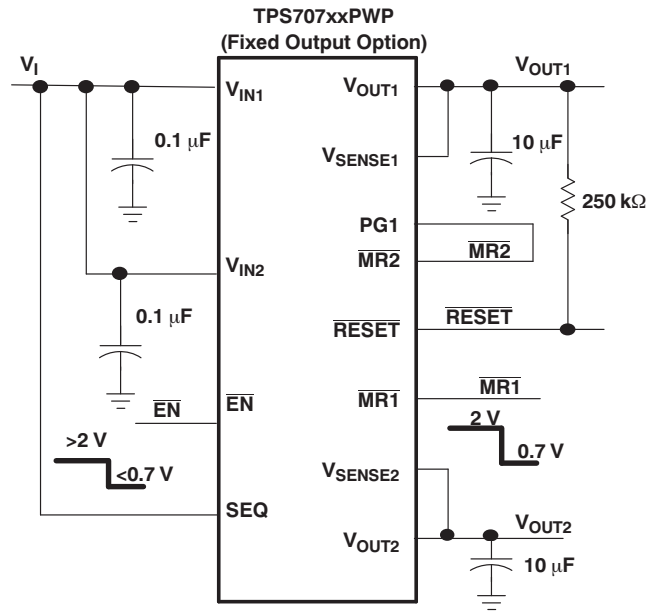


NOTE A: t_1 – Time at which both V_{OUT1} and V_{OUT2} are greater than the PG1 thresholds and MR1 is logic high.

Figure 37. Timing when SEQ = High

Application condition: V_{IN1} and V_{IN2} are tied to the same fixed input voltage greater than the V_{UVLO} ; SEQ is tied to logic high; $PG1$ is tied to $MR2$; $MR1$ is initially at logic high but is eventually toggled.

\overline{EN} is initially high; therefore, both regulators are off and $PG1$ and $RESET$ are at logic low. With SEQ at logic high, when \overline{EN} is taken low, V_{OUT2} turns on. V_{OUT1} turns on after V_{OUT2} reaches 83% of its regulated output voltage. When V_{OUT1} reaches 95% of its regulated output voltage, $PG1$ (tied to $MR2$) goes to logic high. When both V_{OUT1} and V_{OUT2} reach 95% of their respective regulated output voltages and both $MR1$ and $MR2$ (tied to $PG1$) are at logic high, $RESET$ is pulled to logic high after a 120ms delay. When $MR1$ is taken low, $RESET$ returns to logic low but the outputs remain in regulation. When $MR1$ is returned to logic high, since both V_{OUT1} and V_{OUT2} remain above 95% of their respective regulated output voltages and $MR2$ (tied to $PG1$) remains at logic high, $RESET$ is pulled to logic high after a 120ms delay.

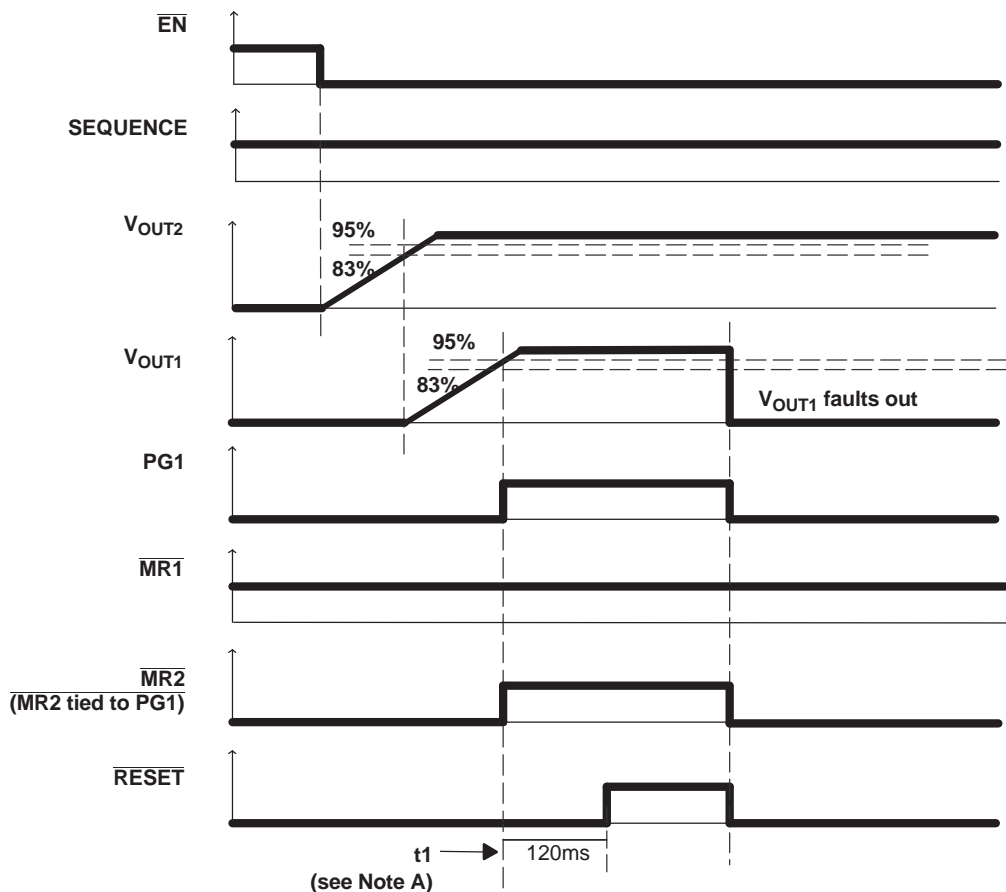
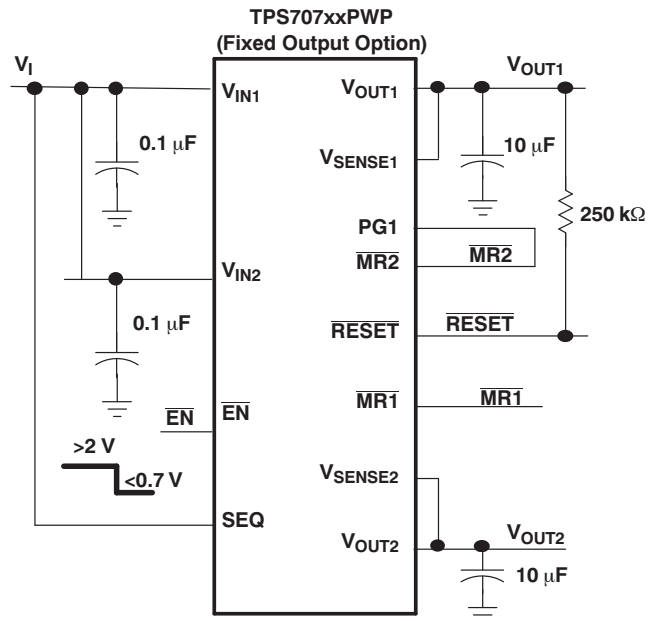


NOTE A: t_1 – Time at which both V_{OUT1} and V_{OUT2} are greater than the $PG1$ thresholds and $\overline{MR1}$ is logic high.

Figure 38. Timing when $\overline{MR1}$ is Toggled

Application condition: V_{IN1} and V_{IN2} are tied to the same fixed input voltage greater than the V_{UVLO} ; SEQ is tied to logic high; PG1 is tied to MR2; MR1 is left unconnected and is therefore at logic high.

\overline{EN} is initially high; therefore, both regulators are off and PG1 and RESET are at logic low. With SEQ at logic high, when \overline{EN} is taken low, V_{OUT2} turns on. V_{OUT1} turns on after V_{OUT2} reaches 83% of its regulated output voltage. When V_{OUT1} reaches 95% of its regulated output voltage, PG1 (tied to MR2) goes to logic high. When both V_{OUT1} and V_{OUT2} reach 95% of their respective regulated output voltages and both MR1 and MR2 (tied to PG1) are at logic high, RESET is pulled to logic high after a 120ms delay. When a fault on V_{OUT1} causes it to fall below 95% of its regulated output voltage, PG1 (tied to MR2) goes to logic low, causing RESET to return to logic low. V_{OUT2} remains on because SEQ is high.

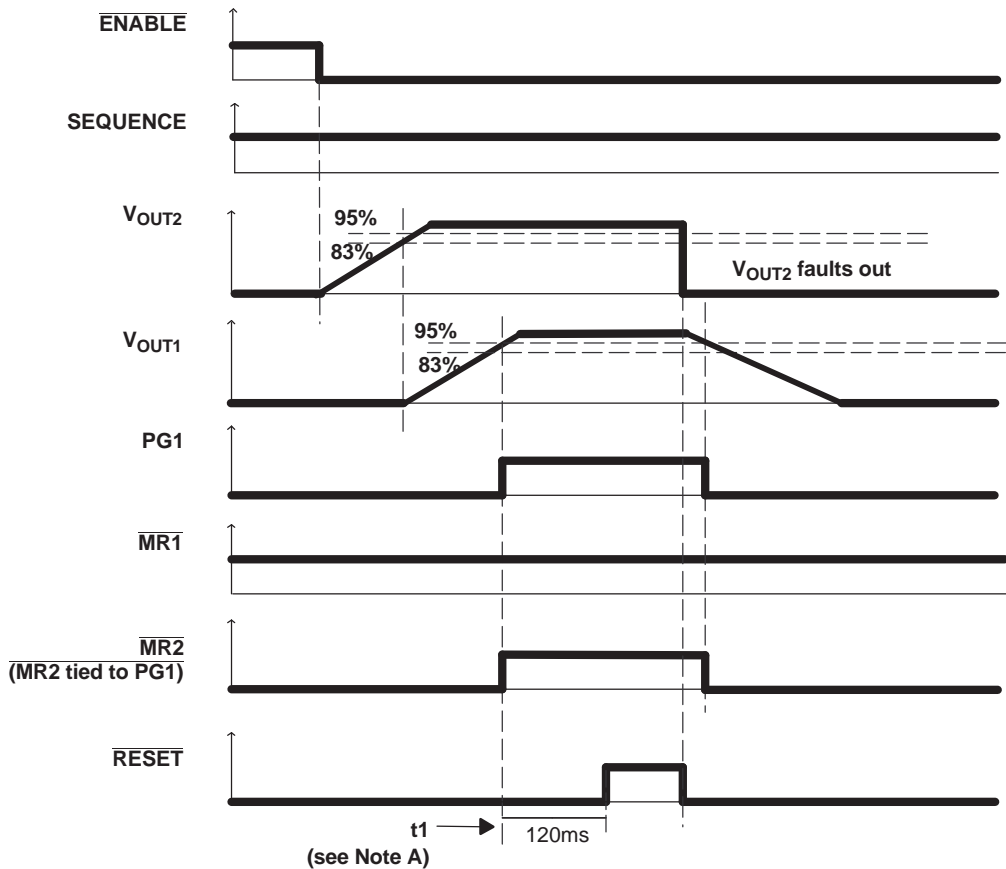
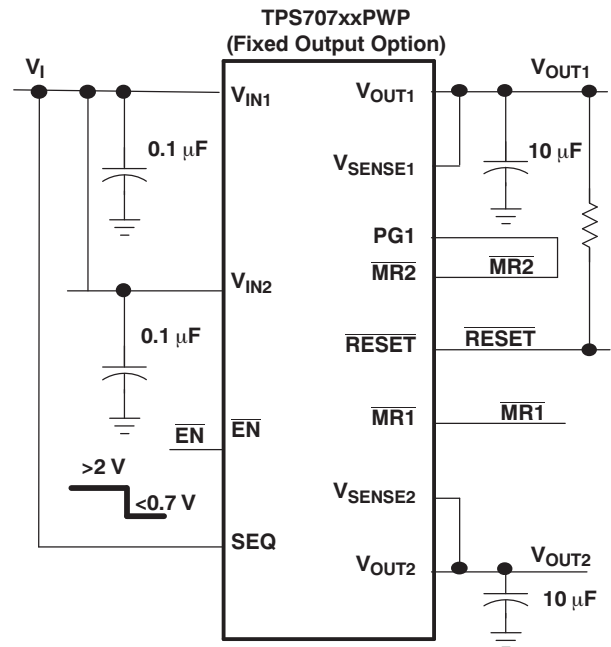


NOTE A: t_1 – Time at which both V_{OUT1} and V_{OUT2} are greater than the PG1 thresholds and MR1 is logic high.

Figure 39. Timing when V_{OUT1} Faults Out

Application condition: V_{IN1} and V_{IN2} are tied to the same fixed input voltage greater than the V_{UVLO} ; SEQ is tied to logic high; PG1 is tied to MR2; MR1 is left unconnected and is therefore at logic high.

\overline{EN} is initially high; therefore, both regulators are off and PG1 and RESET are at logic low. With SEQ at logic high, when \overline{EN} is taken low, V_{OUT2} turns on. V_{OUT1} turns on after V_{OUT2} reaches 83% of its regulated output voltage. When V_{OUT1} reaches 95% of its regulated output voltage, PG1 (tied to MR2) goes to logic high. When both V_{OUT1} and V_{OUT2} reach 95% of their respective regulated output voltages and both MR1 and MR2 (tied to PG1) are at logic high, RESET is pulled to logic high after a 120ms delay. When a fault on V_{OUT2} causes it to fall below 95% of its regulated output voltage, RESET returns to logic low and V_{OUT1} begins to power down because SEQ is high. When V_{OUT1} falls below 95% of its regulated output voltage, PG1 (tied to MR2) returns to logic low.

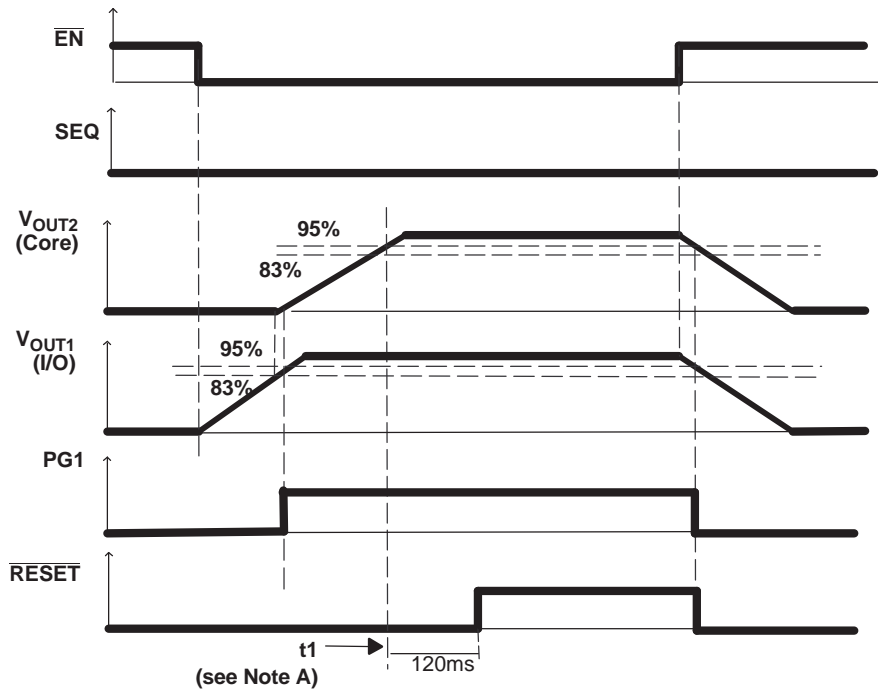
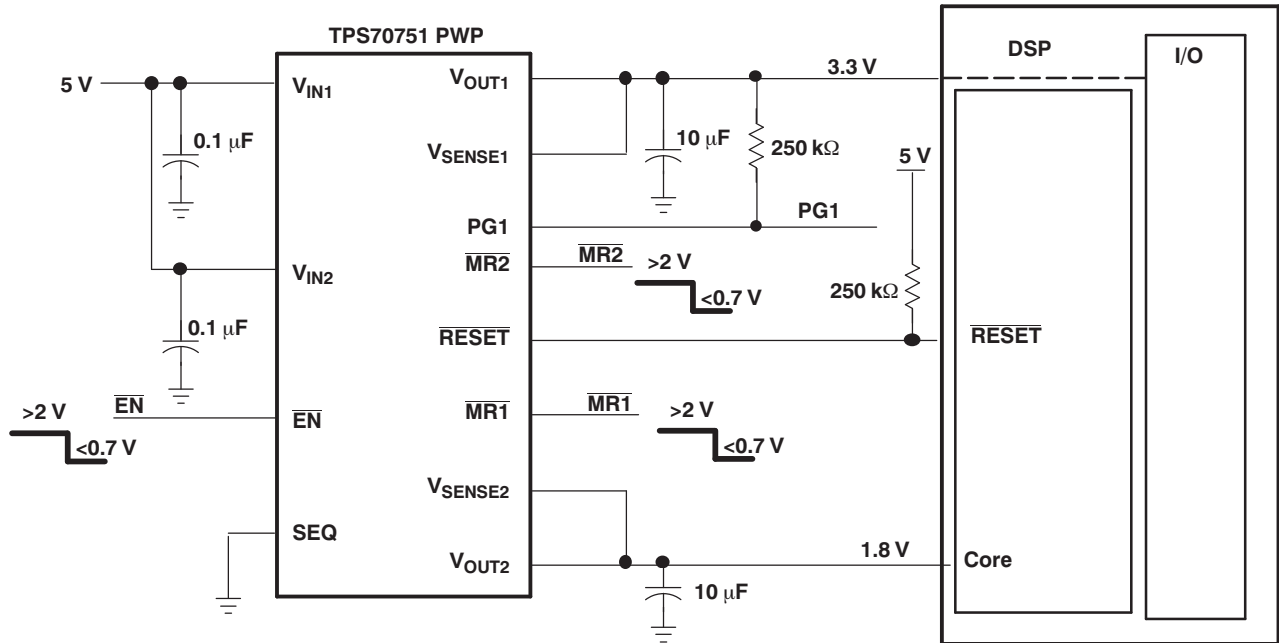


NOTE A: t_1 – Time at which both V_{OUT1} and V_{OUT2} are greater than the PG1 thresholds and $\overline{MR1}$ is logic high.

Figure 40. Timing when V_{OUT2} Faults Out

Split Voltage DSP Application

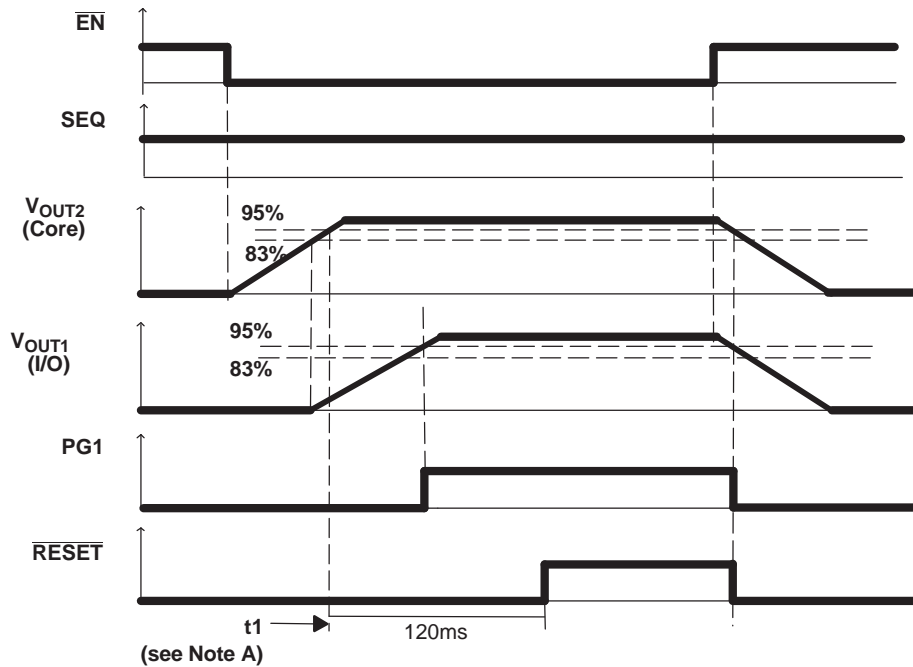
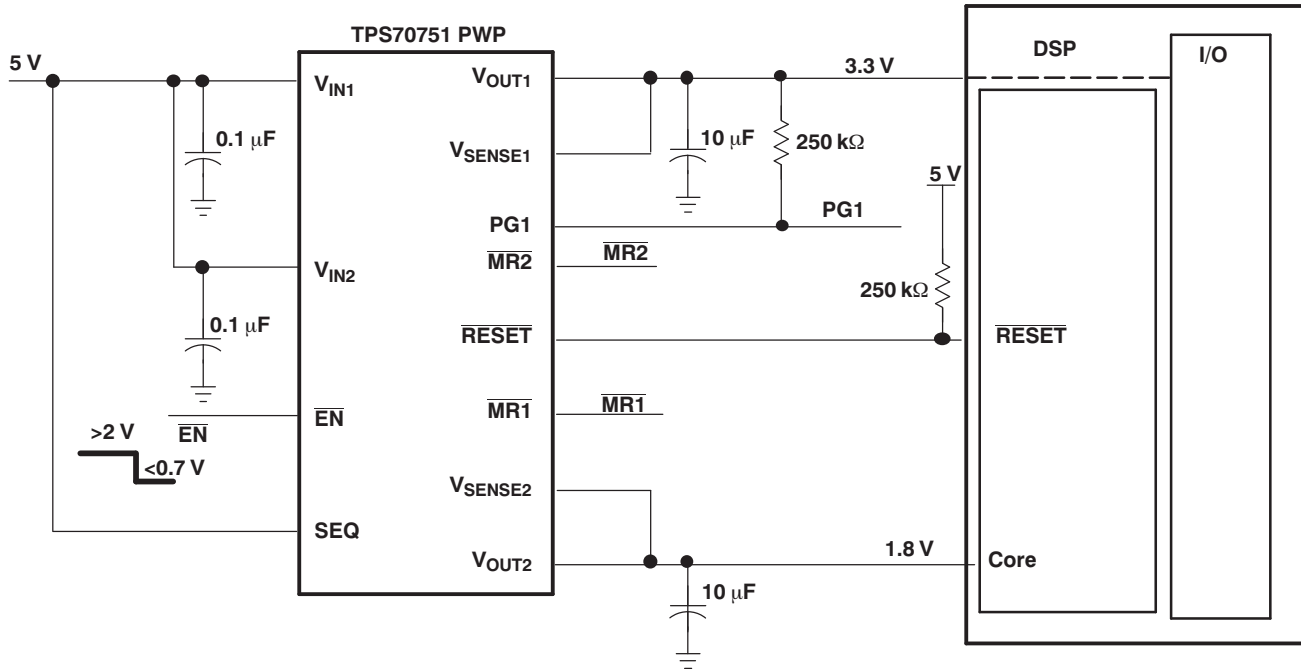
Figure 41 shows a typical application where the TPS70751 is powering up a DSP. In this application, by grounding the SEQ pin, V_{OUT1} (I/O) is powered up first, and then V_{OUT2} (core).



NOTE A: t_1 – Time at which both V_{OUT1} and V_{OUT2} are greater than the PG1 thresholds and $\overline{MR1}$ is logic high.

Figure 41. Application Timing Diagram (SEQ = Low)

Figure 42 shows a typical application where the TPS70751 is powering up a DSP. In this application, by pulling up the SEQ pin, V_{OUT2} (core) is powered up first, and then V_{OUT1} (I/O).



NOTE A: t_1 – Time at which both V_{OUT1} and V_{OUT2} are greater than the PG1 thresholds and $\overline{MR1}$ is logic high.

Figure 42. Application Timing Diagram (SEQ = High)

Input Capacitor

For a typical application, an input bypass capacitor (0.1 μ F to 1 μ F) is recommended. This capacitor filters any high-frequency noise generated in the line. For fast transient conditions where droop at the input of the LDO may occur because of high inrush current, it is recommended to place a larger capacitor at the input as well. The size of this capacitor depends on the output current and response time of the main power supply, as well as the distance to the V_I pins of the LDO.

Output Capacitor

As with most LDO regulators, the TPS707xx requires an output capacitor connected between OUT and GND to stabilize the internal control loop. The minimum recommended capacitance value is 10 μ F and the ESR (equivalent series resistance) must be between 50m Ω and 2.5 Ω . Capacitor values 10 μ F or larger are acceptable, provided the ESR is less than 2.5 Ω . Solid tantalum electrolytic, aluminum electrolytic, and multilayer ceramic capacitors are all suitable, provided they meet the requirements described above. Larger capacitors provide a wider range of stability and better load transient response. [Table 3](#) provides a partial listing of surface-mount capacitors suitable for use with the TPS707xx for fast transient response application.

This information, along with the ESR graphs, is included to assist in selection of suitable capacitance for the user application. When necessary to achieve low height requirements along with high output current and/or high load capacitance, several higher ESR capacitors can be used in parallel to meet the guidelines above.

Table 3. Partial Listing of TPS707xx-Compatible Surface-Mount Capacitors

| VALUE | MANUFACTURER | MAXIMUM ESR | MFR PART NO. |
|-------|--------------|---------------|-----------------|
| 22F | Kemet | 345m Ω | 7495C226K0010AS |
| 33F | Sanyo | 100m Ω | 10TPA33M |
| 47F | Sanyo | 100m Ω | 6TPA47M |
| 68F | Sanyo | 45m Ω | 10TPC68M |

ESR and Transient Response

LDOs typically require an external output capacitor for stability. In fast transient response applications, capacitors are used to support the load current while the LDO amplifier is responding. In most applications, one capacitor is used to support both functions.

Besides its capacitance, every capacitor also contains parasitic impedances. These parasitic impedances are resistive as well as inductive. The resistive impedance is called *equivalent series resistance* (ESR), and the inductive impedance is called *equivalent series inductance* (ESL). The equivalent schematic diagram of any capacitor can therefore be drawn as shown in [Figure 43](#).



Figure 43. ESR and ESL

In most cases one can neglect the effect of inductive impedance ESL. Therefore, the following application focuses mainly on the parasitic resistance ESR.

Figure 44 shows the output capacitor and its parasitic resistances in a typical LDO output stage.

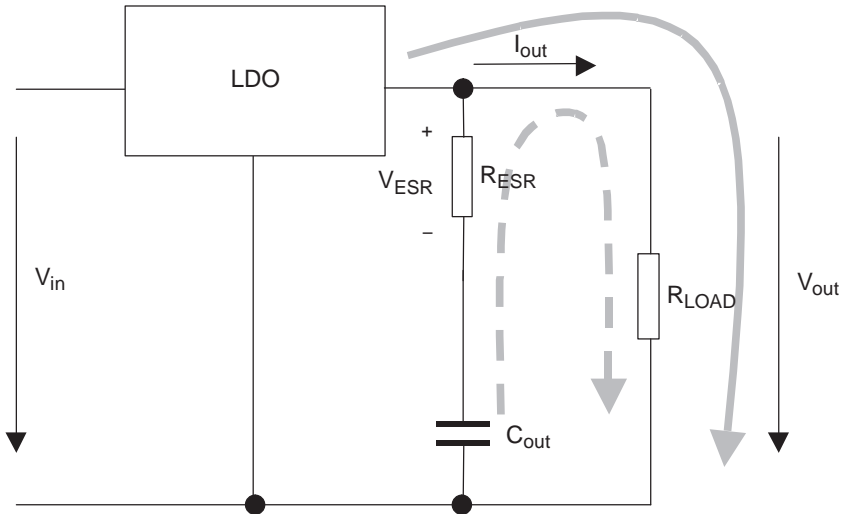


Figure 44. LDO Output Stage with Parasitic Resistances ESR

In steady state (dc state condition), the load current is supplied by the LDO (solid arrow) and the voltage across the capacitor is the same as the output voltage ($V_{(CO)} = V_{OUT}$). This condition means no current is flowing into the C_O branch. If I_{OUT} suddenly increases (a transient condition), the following results occur:

- The LDO is not able to supply the sudden current need because of its response time (t_1 in Figure 45). Therefore, capacitor C_O provides the current for the new load condition (dashed arrow). C_O now acts like a battery with an internal resistance, ESR. Depending on the current demand at the output, a voltage drop occurs at R_{ESR} . This voltage is shown as V_{ESR} in Figure 40.
- When C_O is conducting current to the load, initial voltage at the load will be $V_O = V_{(CO)} - V_{ESR}$. As a result of the discharge of C_O , the output voltage V_O drops continuously until the response time t_1 of the LDO is reached and the LDO resumes supplying the load. From this point, the output voltage starts rising again until it reaches the regulated voltage. This period is shown as t_2 in Figure 45.

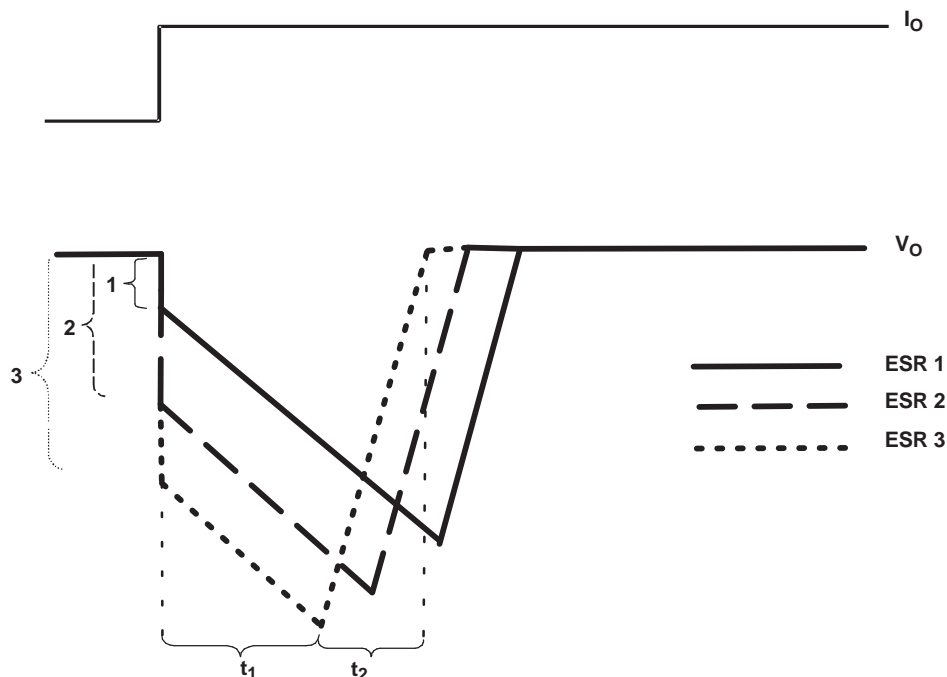


Figure 45. Correlation of Different ESRs and Their Influence on the Regulation of V_O at a Load Step from Low-to-High Output Current

Figure 45 also shows the impact of different ESRs on the output voltage. The left brackets show different levels of ESRs where number 1 displays the lowest and number 3 displays the highest ESR.

From above, the following conclusions can be drawn:

- The higher the ESR, the larger the droop at the beginning of load transient.
- The smaller the output capacitor, the faster the discharge time and the greater the voltage droop during the LDO response period.

Conclusion

To minimize the transient output droop, capacitors must have a low ESR and be large enough to support the minimum output voltage requirement.

Programming the TPS70702 Adjustable LDO Converter

The output voltage of the TPS70702 adjustable regulators are programmed using external resistor dividers as shown in Figure 46.

Resistors R1 and R2 should be chosen for approximately 50 μ A divider current. Lower value resistors can be used, but offer no inherent advantage and waste more power. Higher values should be avoided as leakage currents at the sense terminal increase the output voltage error. The recommended design procedure is to choose R2 = 30.1k Ω to set the divider current at approximately 50 μ A, and then calculate R1 using Equation 1:

$$R1 = \left(\frac{V_O}{V_{ref}} - 1 \right) \times R2 \quad (1)$$

where:

- $V_{REF} = 1.224V$ typ (the internal reference voltage)

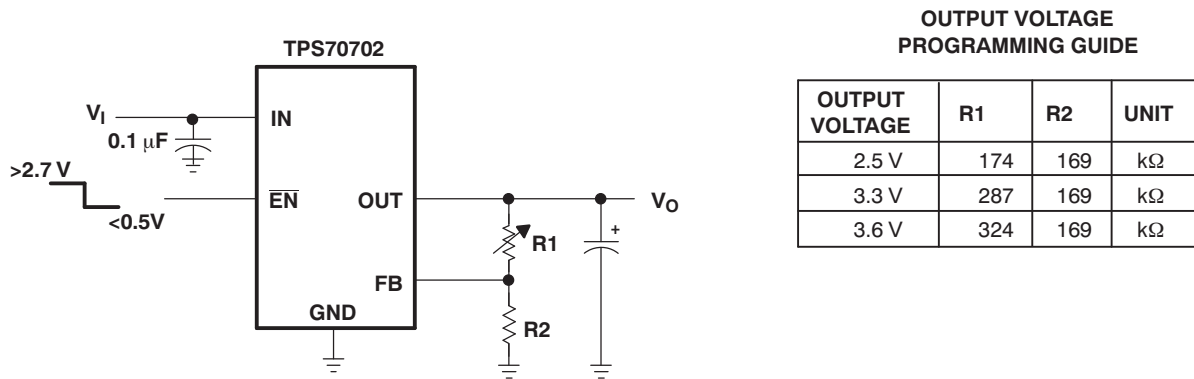


Figure 46. TPS70702 Adjustable LDO Regulator Programming

Regulator Protection

Both TPS707xx PMOS-pass transistors have built-in back diodes that conduct reverse currents when the input voltage drops below the output voltage (for example, during power-down). Current is conducted from the output to the input and is not internally limited. When extended reverse voltage is anticipated, external limiting may be appropriate.

The TPS707xx also features internal current limiting and thermal protection. During normal operation, the TPS707xx regulator 1 limits output current to approximately 1.6A (typ) and regulator 2 limits output current to approximately 750mA (typ). When current limiting engages, the output voltage scales back linearly until the overcurrent condition ends. While current limiting is designed to prevent gross device failure, care should be taken not to exceed the power dissipation ratings of the package. If the temperature of the device exceeds +150°C (typ), thermal-protection circuitry shuts it down. Once the device has cooled below +130°C (typ), regulator operation resumes.

Power Dissipation and Junction Temperature

Specified regulator operation is assured to a junction temperature of +125°C; the maximum junction temperature should be restricted to +125°C under normal operating conditions. This restriction limits the power dissipation the regulator can handle in any given application. To ensure the junction temperature is within acceptable limits, calculate the maximum allowable dissipation, $P_{D(max)}$, and the actual dissipation, P_D , which must be less than or equal to $P_{D(max)}$.

The maximum-power-dissipation limit is determined using [Equation 2](#):

$$P_{D(max)} = \frac{T_{Jmax} - T_A}{R_{\theta JA}} \quad (2)$$

where:

- T_{Jmax} is the maximum allowable junction temperature
- $R_{\theta JA}$ is the thermal resistance junction-to-ambient for the package; that is, 32.6°C/W for the 20-terminal PWP with no airflow
- T_A is the ambient temperature

The regulator dissipation is calculated using [Equation 3](#):

$$P_D = (V_I - V_O) \times I_O \quad (3)$$

Power dissipation resulting from quiescent current is negligible. Excessive power dissipation triggers the thermal protection circuit.

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead/Ball Finish | MSL Peak Temp (3) | Op Temp (°C) | Top-Side Markings (4) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|----------------------------|------------------|----------------------|--------------|--------------------------|-------------------------|
| TPS70702PWP | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70702 | Samples |
| TPS70702PWPG4 | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70702 | Samples |
| TPS70702PWPR | ACTIVE | HTSSOP | PWP | 20 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70702 | Samples |
| TPS70702PWPRG4 | ACTIVE | HTSSOP | PWP | 20 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70702 | Samples |
| TPS70745PWP | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70745 | Samples |
| TPS70745PWPG4 | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70745 | Samples |
| TPS70748PWP | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70748 | Samples |
| TPS70748PWPG4 | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70748 | Samples |
| TPS70751PWP | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70751 | Samples |
| TPS70751PWPG4 | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70751 | Samples |
| TPS70751PWPR | ACTIVE | HTSSOP | PWP | 20 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70751 | Samples |
| TPS70751PWPRG4 | ACTIVE | HTSSOP | PWP | 20 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70751 | Samples |
| TPS70758PWP | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70758 | Samples |
| TPS70758PWPG4 | ACTIVE | HTSSOP | PWP | 20 | 70 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | PT70758 | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSELETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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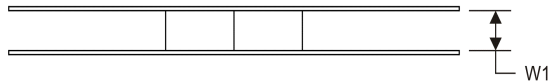
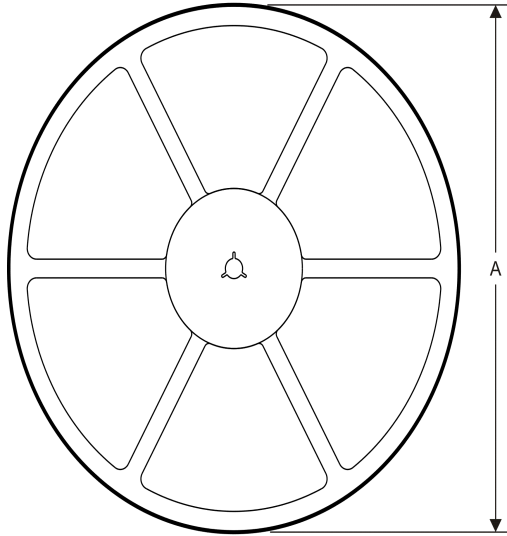
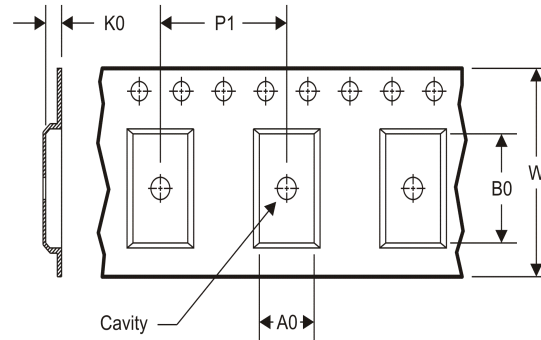
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OTHER QUALIFIED VERSIONS OF TPS70751 :

- Enhanced Product: [TPS70751-EP](#)

NOTE: Qualified Version Definitions:

- Enhanced Product - Supports Defense, Aerospace and Medical Applications

TAPE AND REEL INFORMATION
REEL DIMENSIONS

TAPE DIMENSIONS


| | |
|----|---|
| A0 | Dimension designed to accommodate the component width |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

TAPE AND REEL INFORMATION

*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TPS70702PWPR | HTSSOP | PWP | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.1 | 1.6 | 8.0 | 16.0 | Q1 |
| TPS70751PWPR | HTSSOP | PWP | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.1 | 1.6 | 8.0 | 16.0 | Q1 |

TAPE AND REEL BOX DIMENSIONS

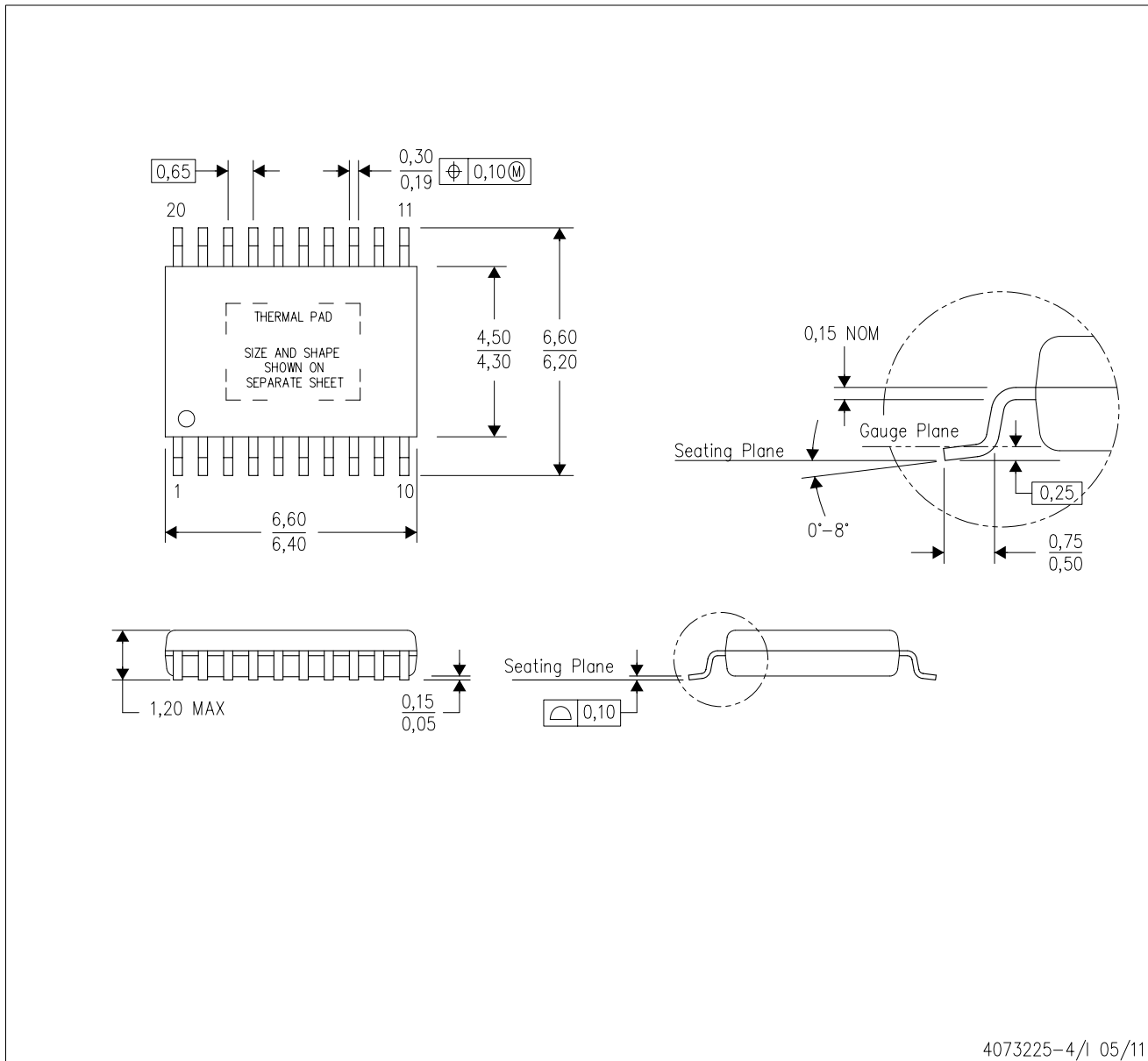

*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TPS70702PWPR | HTSSOP | PWP | 20 | 2000 | 367.0 | 367.0 | 38.0 |
| TPS70751PWPR | HTSSOP | PWP | 20 | 2000 | 367.0 | 367.0 | 38.0 |

MECHANICAL DATA

PWP (R-PDSO-G20)

PowerPAD™ PLASTIC SMALL OUTLINE



4073225-4/1 05/11

- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Body dimensions do not include mold flash or protrusions. Mold flash and protrusion shall not exceed 0.15 per side.
 - This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <<http://www.ti.com>>.
 - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - Falls within JEDEC MO-153

PowerPAD is a trademark of Texas Instruments.

THERMAL PAD MECHANICAL DATA

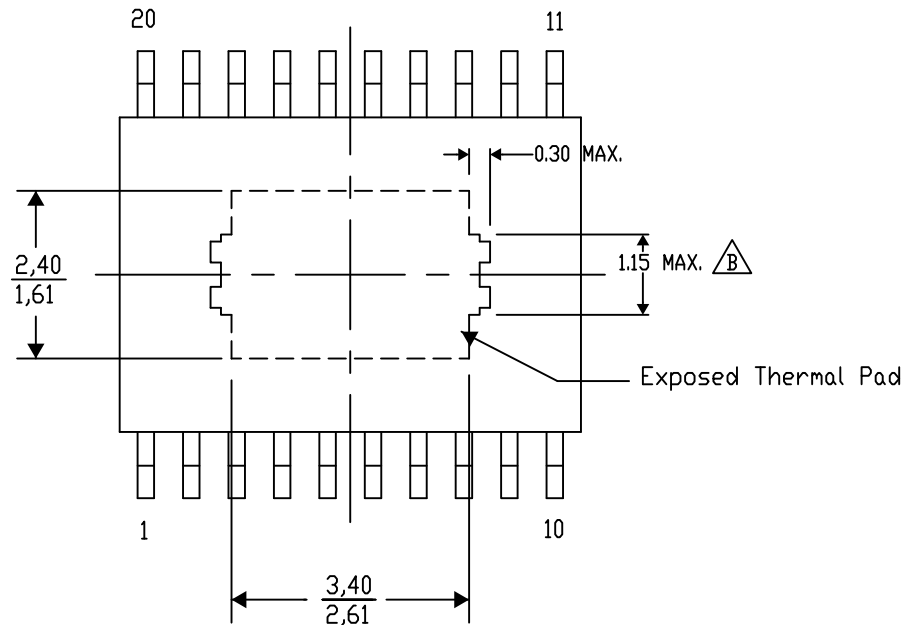
PWP (R-PDSO-G20) PowerPAD™ SMALL PLASTIC OUTLINE

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Top View

Exposed Thermal Pad Dimensions

4206332-15/AO 01/16

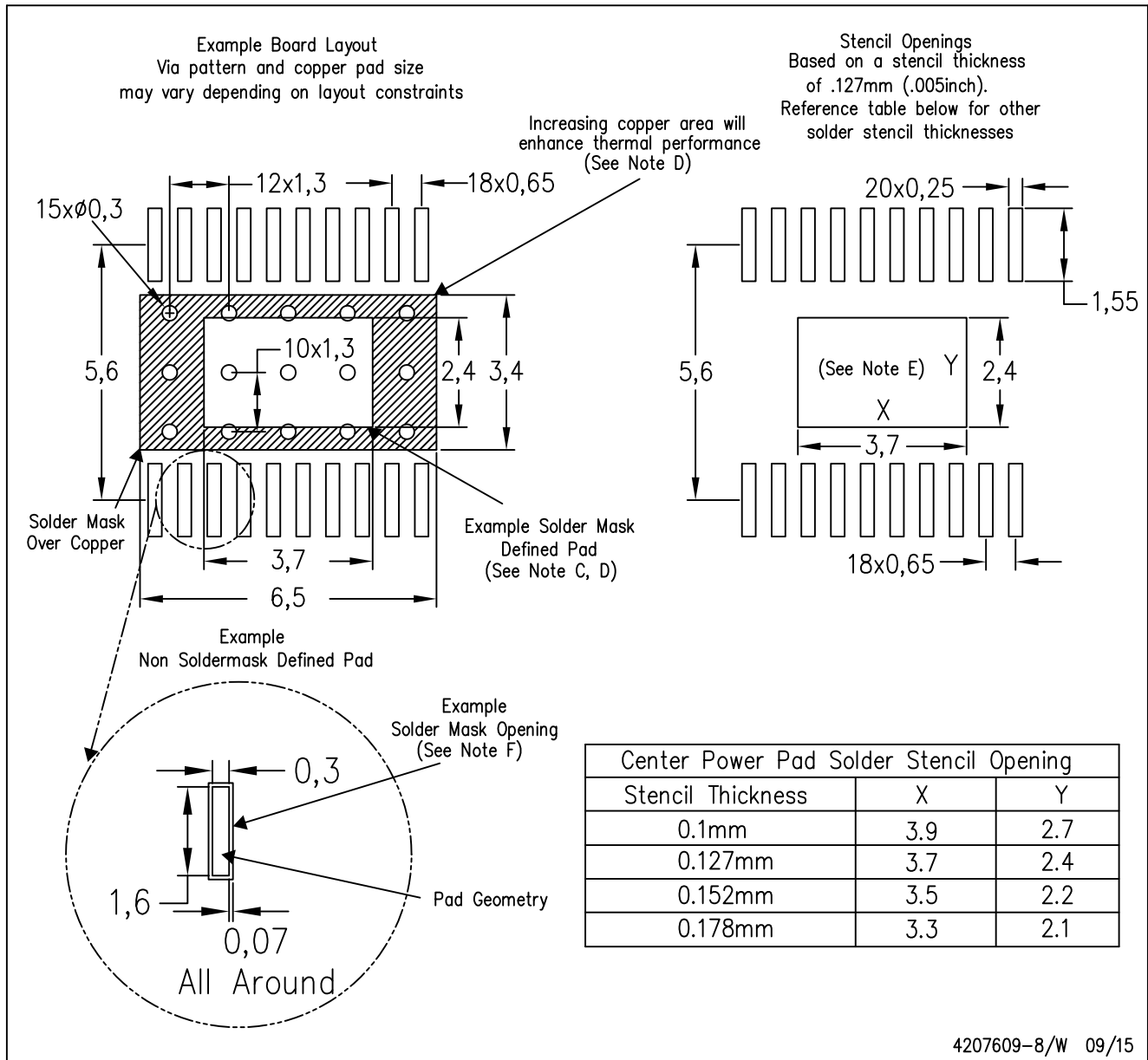
NOTE: A. All linear dimensions are in millimeters

 Exposed tie strap features may not be present.

PowerPAD is a trademark of Texas Instruments

PWP (R-PDSO-G20)

PowerPAD™ PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
 - This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>. Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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